

MSP430C11x1, MSP430F11x1A MIXED SIGNAL MICROCONTROLLER

SLAS241G – SEPTEMBER 1999 – REVISED AUGUST 2003

- Low Supply Voltage Range 1.8 V – 3.6 V
- Ultralow-Power Consumption
 - Active Mode: 160 μ A at 1 MHz, 2.2 V
 - Standby Mode: 0.7 μ A
 - Off Mode (RAM Retention): 0.1 μ A
- Wake-Up From Standby Mode in less than 6 μ s
- 16-Bit RISC Architecture, 125 ns Instruction Cycle Time
- Basic Clock Module Configurations:
 - Various Internal Resistors
 - Single External Resistor
 - 32-kHz Crystal
 - High-Frequency Crystal
 - Resonator
 - External Clock Source
- 16-Bit Timer_A With Three Capture/Compare Registers
- Slope A/D Converter With External Components
- On-Chip Comparator for Analog Signal Compare Function or Slope A/D Conversion
- Serial Onboard Programming, No External Programming Voltage Needed Programmable Code Protection by Security Fuse
- Family Members Include:
 - MSP430C1101: 1KB ROM, 128B RAM
 - MSP430C1111: 2KB ROM, 128B RAM
 - MSP430C1121: 4KB ROM, 256B RAM
 - MSP430F1101A: 1KB + 128B Flash Memory 128B RAM
 - MSP430F1111A: 2KB + 256B Flash Memory 128B RAM
 - MSP430F1121A: 4KB + 256B Flash Memory 256B RAM
- Available in a 20-Pin Plastic Small-Outline Wide Body (SOWB) Package, 20-Pin Plastic Small-Outline Thin Package, 20-Pin TVSOP (F11x1A only) and 24-Pin QFN†
- For Complete Module Descriptions, Refer to the MSP430x1xx Family User's Guide, Literature Number SLAU049

description

The Texas Instruments MSP430 family of ultralow power microcontrollers consist of several devices featuring different sets of peripherals targeted for various applications. The architecture, combined with five low power modes is optimized to achieve extended battery life in portable measurement applications. The device features a powerful 16-bit RISC CPU, 16-bit registers, and constant generators that attribute to maximum code efficiency. The digitally controlled oscillator (DCO) allows wake-up from low-power modes to active mode in less than 6 μ s.

The MSP430x11x1 series is an ultralow-power mixed signal microcontroller with a built-in 16-bit timer, versatile analog comparator and fourteen I/O pins.

Typical applications include sensor systems that capture analog signals, convert them to digital values, and then process the data for display or for transmission to a host system. Stand alone RF sensor front end is another area of application. The I/O port inputs provide single slope A/D conversion capability on resistive sensors.

AVAILABLE OPTIONS

T _A	PACKAGED DEVICES			
	PLASTIC 20-PIN SOWB (DW)	PLASTIC 20-PIN TSSOP (PW)	PLASTIC 20-PIN TVSOP (DGV)	PLASTIC 24-PIN QFN (RGE)
-40°C to 85°C	MSP430C1101IDW MSP430C1111IDW MSP430C1121IDW MSP430F1101AIDW MSP430F1111AIDW MSP430F1121AIDW	MSP430C1101IPW MSP430C1111IPW MSP430C1121IPW MSP430F1101AIPW MSP430F1111AIPW MSP430F1121AIPW	MSP430F1101AIDGV MSP430F1111AIDGV MSP430F1121AIDGV	MSP430C1101IRGE† MSP430C1111IRGE† MSP430C1121IRGE† MSP430F1101AIRGE† MSP430F1111AIRGE† MSP430F1121AIRGE†



† Product Preview

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Terminal Functions

TERMINAL				DESCRIPTION
NAME	DW, PW, or DGV NO.	RGE NO.	I/O	
P1.0/TACLK	13	13	I/O	General-purpose digital I/O pin/Timer_A, clock signal TACLK input
P1.1/TA0	14	14	I/O	General-purpose digital I/O pin/Timer_A, capture: CCI0A input, compare: Out0 output/BSL transmit
P1.2/TA1	15	15	I/O	General-purpose digital I/O pin/Timer_A, capture: CCI1A input, compare: Out1 output
P1.3/TA2	16	16	I/O	General-purpose digital I/O pin/Timer_A, capture: CCI2A input, compare: Out2 output
P1.4/SMCLK/TCK	17	17	I/O	General-purpose digital I/O pin/SMCLK signal output/test clock, input terminal for device programming and test
P1.5/TA0/TMS	18	18	I/O	General-purpose digital I/O pin/Timer_A, compare: Out0 output/test mode select, input terminal for device programming and test
P1.6/TA1/TDI	19	20	I/O	General-purpose digital I/O pin/Timer_A, compare: Out1 output/test data input terminal
P1.7/TA2/TDO/TDI†	20	21	I/O	General-purpose digital I/O pin/Timer_A, compare: Out2 output/test data output terminal or data input during programming
P2.0/ACLK	8	6	I/O	General-purpose digital I/O pin/ACLK output
P2.1/INCLK	9	7	I/O	General-purpose digital I/O pin/Timer_A, clock signal at INCLK
P2.2/CAOUT/TA0	10	8	I/O	General-purpose digital I/O pin/Timer_A, capture: CCI0B input/comparator_A, output/BSL receive
P2.3/CA0/TA1	11	10	I/O	General-purpose digital I/O pin/Timer_A, compare: Out1 output/comparator_A, input
P2.4/CA1/TA2	12	11	I/O	General-purpose digital I/O pin/Timer_A, compare: Out2 output/comparator_A, input
P2.5/R _{Osc}	3	24	I/O	General-purpose digital I/O pin/input for external resistor that defines the DCO nominal frequency
RST/NMI	7	5	I	Reset or nonmaskable interrupt input
TEST	1	22	I	Selects test mode for JTAG pins on Port1. The device protection fuse is connected to TEST.
V _{CC}	2	23		Supply voltage
V _{SS}	4	2		Ground reference
XIN	6	4	I	Input terminal of crystal oscillator
XOUT	5	3	I/O	Output terminal of crystal oscillator

† TDO or TDI is selected via JTAG instruction.



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short-form description

CPU

The MSP430 CPU has a 16-bit RISC architecture that is highly transparent to the application. All operations, other than program-flow instructions, are performed as register operations in conjunction with seven addressing modes for source operand and four addressing modes for destination operand.

The CPU is integrated with 16 registers that provide reduced instruction execution time. The register-to-register operation execution time is one cycle of the CPU clock.

Four of the registers, R0 to R3, are dedicated as program counter, stack pointer, status register, and constant generator respectively. The remaining registers are general-purpose registers.

Peripherals are connected to the CPU using data, address, and control buses, and can be handled with all instructions.

instruction set

The instruction set consists of 51 instructions with three formats and seven address modes. Each instruction can operate on word and byte data. Table 1 shows examples of the three types of instruction formats; the address modes are listed in Table 2.

Program Counter	PC/R0
Stack Pointer	SP/R1
Status Register	SR/CG1/R2
Constant Generator	CG2/R3
General-Purpose Register	R4
General-Purpose Register	R5
General-Purpose Register	R6
General-Purpose Register	R7
General-Purpose Register	R8
General-Purpose Register	R9
General-Purpose Register	R10
General-Purpose Register	R11
General-Purpose Register	R12
General-Purpose Register	R13
General-Purpose Register	R14
General-Purpose Register	R15

Table 1. Instruction Word Formats

Dual operands, source-destination	e.g. ADD R4,R5	R4 + R5 ----> R5
Single operands, destination only	e.g. CALL R8	PC -->(TOS), R8--> PC
Relative jump, un/conditional	e.g. JNE	Jump-on-equal bit = 0

Table 2. Address Mode Descriptions

ADDRESS MODE	S	D	SYNTAX	EXAMPLE	OPERATION
Register	●	●	MOV Rs,Rd	MOV R10,R11	R10 --> R11
Indexed	●	●	MOV X(Rn),Y(Rm)	MOV 2(R5),6(R6)	M(2+R5)--> M(6+R6)
Symbolic (PC relative)	●	●	MOV EDE,TONI		M(EDE) --> M(TONI)
Absolute	●	●	MOV &MEM,&TCDAT		M(MEM) --> M(TCDAT)
Indirect	●		MOV @Rn,Y(Rm)	MOV @R10,Tab(R6)	M(R10) --> M(Tab+R6)
Indirect autoincrement	●		MOV @Rn+,Rm	MOV @R10+,R11	M(R10) --> R11 R10 + 2--> R10
Immediate	●		MOV #X,TONI	MOV #45,TONI	#45 --> M(TONI)

NOTE: S = source D = destination



operating modes

The MSP430 has one active mode and five software selectable low-power modes of operation. An interrupt event can wake up the device from any of the five low-power modes, service the request and restore back to the low-power mode on return from the interrupt program.

The following six operating modes can be configured by software:

- Active mode AM;
 - All clocks are active
- Low-power mode 0 (LPM0);
 - CPU is disabled
ACLK and SMCLK remain active. MCLK is disabled
- Low-power mode 1 (LPM1);
 - CPU is disabled
ACLK and SMCLK remain active. MCLK is disabled
DCO's dc-generator is disabled if DCO not used in active mode
- Low-power mode 2 (LPM2);
 - CPU is disabled
MCLK and SMCLK are disabled
DCO's dc-generator remains enabled
ACLK remains active
- Low-power mode 3 (LPM3);
 - CPU is disabled
MCLK and SMCLK are disabled
DCO's dc-generator is disabled
ACLK remains active
- Low-power mode 4 (LPM4);
 - CPU is disabled
ACLK is disabled
MCLK and SMCLK are disabled
DCO's dc-generator is disabled
Crystal oscillator is stopped

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interrupt vector addresses

The interrupt vectors and the power-up starting address are located in the memory with an address range of 0FFFFh–0FFE0h. The vector contains the 16-bit address of the appropriate interrupt handler instruction sequence.

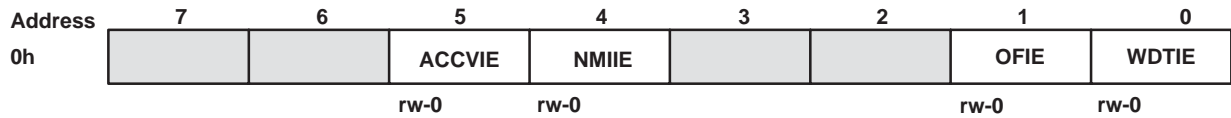
INTERRUPT SOURCE	INTERRUPT FLAG	SYSTEM INTERRUPT	WORD ADDRESS	PRIORITY
Power-up, external reset, watchdog	WDTIFG (Note1) KEYV (Note 1)	Reset	0FFFEh	15, highest
NMI, oscillator fault, flash memory access violation	NMIIFG (Notes 1 and 4) OFIFG (Notes 1 and 4) ACCVIFG (Notes 1 and 4)	(non)-maskable, (non)-maskable, (non)-maskable	0FFFCh	14
			0FFFAh	13
			0FFF8h	12
Comparator_A	CAIFG	maskable	0FFF6h	11
Watchdog Timer	WDTIFG	maskable	0FFF4h	10
Timer_A	TACCR0 CCIFG (Note 2)	maskable	0FFF2h	9
Timer_A	TACCR1 and TACCR2 CCIFGs, TAIFG (Notes 1 and 2)	maskable	0FFF0h	8
			0FFEEh	7
			0FFECCh	6
			0FFEAh	5
			0FFE8h	4
I/O Port P2 (eight flags – see Note 3)	P2IFG.0 to P2IFG.7 (Notes 1 and 2)	maskable	0FFE6h	3
I/O Port P1 (eight flags)	P1IFG.0 to P1IFG.7 (Notes 1 and 2)	maskable	0FFE4h	2
			0FFE2h	1
			0FFE0h	0, lowest

- NOTES:
- Multiple source flags
 - Interrupt flags are located in the module
 - There are eight Port P2 interrupt flags, but only six Port P2 I/O pins (P2.0–5) implemented on the 'C11x1 and 'F11x1A devices.
 - (non)-maskable: the individual interrupt-enable bit can disable an interrupt event, but the general interrupt enable cannot.
Nonmaskable: neither the individual nor the general interrupt-enable bit will disable an interrupt event.

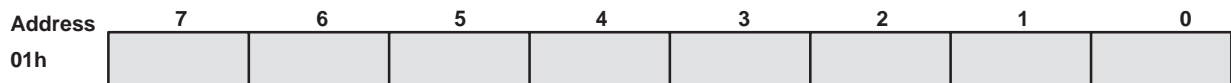
special function registers

Most interrupt and module enable bits are collected into the lowest address space. Special function register bits not allocated to a functional purpose are not physically present in the device. Simple software access is provided with this arrangement.

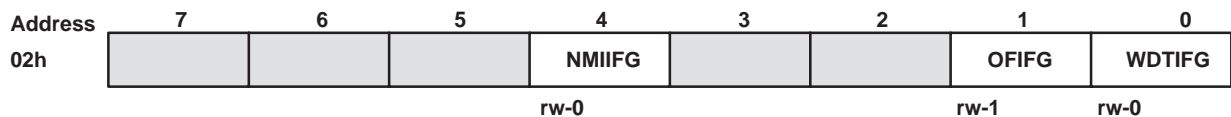
interrupt enable 1 and 2



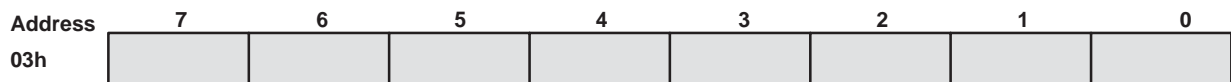
- WDTIE: Watchdog Timer interrupt enable. Inactive if watchdog mode is selected. Active if Watchdog Timer is configured in interval timer mode.
- OFIE: Oscillator fault enable
- NMIIE: (Non)maskable interrupt enable
- ACCVIE: Flash access violation interrupt enable



interrupt flag register 1 and 2



- WDTIFG: Set on Watchdog Timer overflow (in watchdog mode) or security key violation. Reset on V_{CC} power-up or a reset condition at RST/NMI pin in reset mode.
- OFIFG: Flag set on oscillator fault
- NMIIFG: Set via RST/NMI-pin

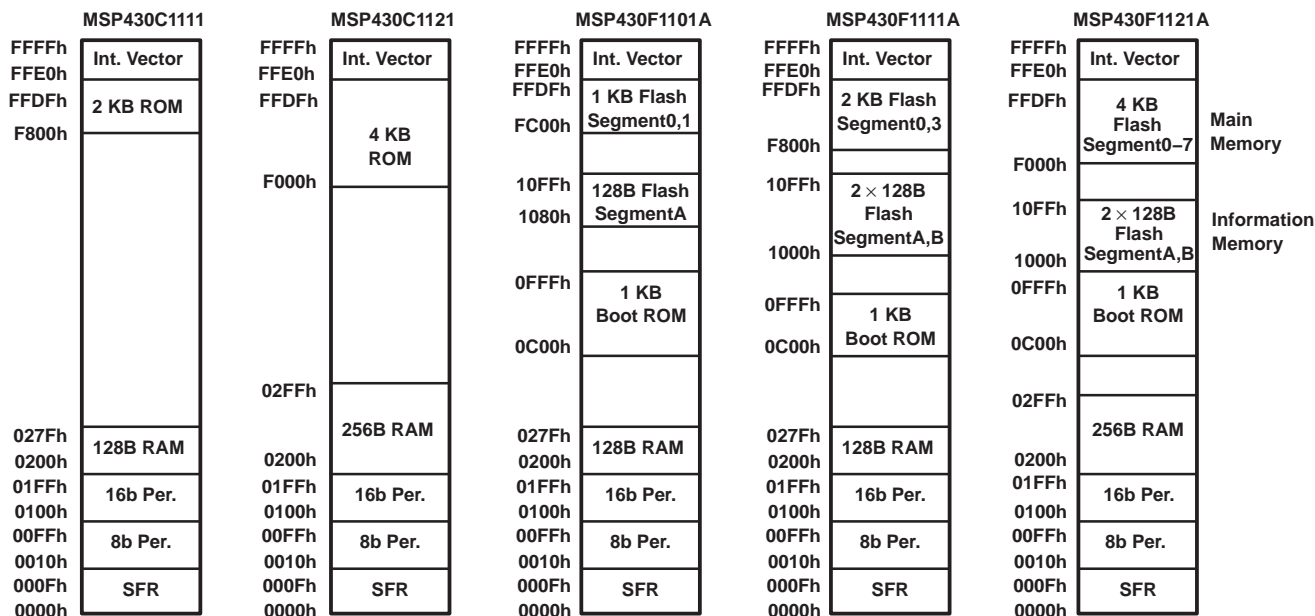


- Legend**
- rw:** Bit can be read and written.
- rw-0:** Bit can be read and written. It is reset by PUC.
- SFR bit is not present in device.

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memory organization



bootstrap loader (BSL)

The MSP430 bootstrap loader (BSL) enables users to program the flash memory or RAM using a UART serial interface. Access to the MSP430 memory via the BSL is protected by user-defined password. For complete description of the features of the BSL and its implementation, see the Application report *Features of the MSP430 Bootstrap Loader*, Literature Number SLAA089.

BSL Function	DW, PW, & DGV Pin	RGE Pin
Data Transmit	14 - P1.1	14 - P1.1
Data Receive	10 - P2.2	8 - P2.2

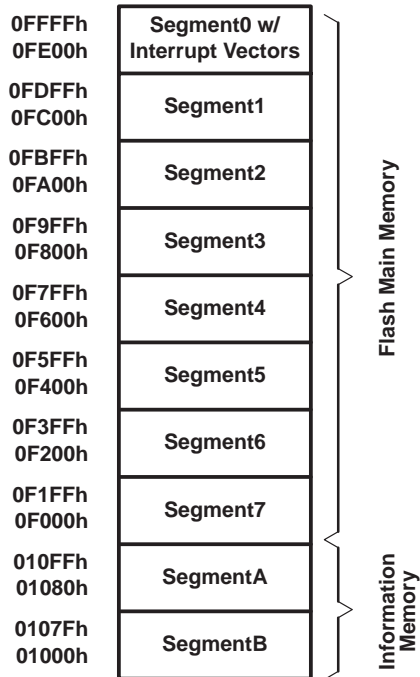
flash memory

The flash memory can be programmed via the JTAG port, the bootstrap loader, or in-system by the CPU. The CPU can perform single-byte and single-word writes to the flash memory. Features of the flash memory include:

- Flash memory has n segments of main memory and two segments of information memory (A and B) of 128 bytes each. Each segment in main memory is 512 bytes in size.
- Segments 0 to n may be erased in one step, or each segment may be individually erased.
- Segments A and B can be erased individually, or as a group with segments 0–n. Segments A and B are also called *information memory*.
- New devices may have some bytes programmed in the information memory (needed for test during manufacturing). The user should perform an erase of the information memory prior to the first use.



flash memory (continued)



NOTE: All segments not implemented on all devices.

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peripherals

Peripherals are connected to the CPU through data, address, and control busses and can be handled using all instructions. For complete module descriptions, refer to the MSP430x1xx Family User's Guide, literature number SLAU049.

oscillator and system clock

The clock system is supported by the basic clock module that includes support for a 32768-Hz watch crystal oscillator, an internal digitally-controlled oscillator (DCO) and a high frequency crystal oscillator. The basic clock module is designed to meet the requirements of both low system cost and low-power consumption. The internal DCO provides a fast turn-on clock source and stabilizes in less than 6 μ s. The basic clock module provides the following clock signals:

- Auxiliary clock (ACLK), sourced from a 32768-Hz watch crystal or a high frequency crystal.
- Main clock (MCLK), the system clock used by the CPU.
- Sub-Main clock (SMCLK), the sub-system clock used by the peripheral modules.

digital I/O

There are two 8-bit I/O ports implemented—ports P1 and P2 (only six P2 I/O signals are available on external pins):

- All individual I/O bits are independently programmable.
- Any combination of input, output, and interrupt conditions is possible.
- Edge-selectable interrupt input capability for all the eight bits of port P1 and six bits of port P2.
- Read/write access to port-control registers is supported by all instructions.

NOTE:

Six bits of port P2, P2.0 to P2.5, are available on external pins – but all control and data bits for port P2 are implemented.

watchdog timer

The primary function of the watchdog timer (WDT) module is to perform a controlled system restart after a software problem occurs. If the selected time interval expires, a system reset is generated. If the watchdog function is not needed in an application, the module can be configured as an interval timer and can generate interrupts at selected time intervals.

comparator_A

The primary function of the comparator_A module is to support precision slope analog-to-digital conversions, battery-voltage supervision, and monitoring of external analog signals.



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timer_A3

Timer_A3 is a 16-bit timer/counter with three capture/compare registers. Timer_A3 can support multiple capture/compares, PWM outputs, and interval timing. Timer_A3 also has extensive interrupt capabilities. Interrupts may be generated from the counter on overflow conditions and from each of the capture/compare registers.

Timer_A3 Signal Connections						
Input Pin Number		Device Input Signal	Module Input Name	Module Output Signal	Output Pin Number	
DW, PW, DGV	RGE				DW, PW, DGV	RGE
13 - P1.0	13 - P1.0	TACLK	TACLK	NA		
		ACLK	ACLK			
		SMCLK	SMCLK			
9 - P2.1	7 - P2.1	INCLK	INCLK			
14 - P1.1	14 - P1.1	TA0	CCI0A	TA0	14 - P1.1	14 - P1.1
10 - P2.2	8 - P2.2	TA0	CCI0B		18 - P1.5	18 - P1.5
		DVss	GND			
		DVCC	VCC			
15 - P1.2	15 - P1.2	TA1	CCI1A	TA1	11 - P2.3	10 - P2.3
		CAOUT (internal)	CCI1B		15 - P1.2	15 - P1.2
		DVss	GND		19 - P1.6	20 - P1.6
		DVCC	VCC			
16 - P1.3	16 - P1.3	TA2	CCI2A	TA2	12 - P2.4	11 - P2.4
		ACLK (internal)	CCI2B		16 - P1.3	16 - P1.3
		DVss	GND		20 - P1.7	21 - P1.7
		DVCC	VCC			

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peripheral file map

PERIPHERALS WITH WORD ACCESS			
Timer_A	Reserved		017Eh
	Reserved		017Ch
	Reserved		017Ah
	Reserved		0178h
	Capture/compare register	TACCR2	0176h
	Capture/compare register	TACCR1	0174h
	Capture/compare register	TACCR0	0172h
	Timer_A register	TAR	0170h
	Reserved		016Eh
	Reserved		016Ch
	Reserved		016Ah
	Reserved		0168h
	Capture/compare control	TACCTL2	0166h
	Capture/compare control	TACCTL1	0164h
	Capture/compare control	TACCTL0	0162h
Timer_A control	TACTL	0160h	
Timer_A interrupt vector	TAIV	012Eh	
Flash Memory	Flash control 3	FCTL3	012Ch
	Flash control 2	FCTL2	012Ah
	Flash control 1	FCTL1	0128h
Watchdog	Watchdog/timer control	WDTCTL	0120h
PERIPHERALS WITH BYTE ACCESS			
Comparator_A	Comparator_A port disable	CAPD	05Bh
	Comparator_A control2	CACTL2	05Ah
	Comparator_A control1	CACTL1	059h
Basic Clock	Basic clock system control2	BCSCTL2	058h
	Basic clock system control1	BCSCTL1	057h
	DCO clock frequency control	DCOCTL	056h
Port P2	Port P2 selection	P2SEL	02Eh
	Port P2 interrupt enable	P2IE	02Dh
	Port P2 interrupt edge select	P2IES	02Ch
	Port P2 interrupt flag	P2IFG	02Bh
	Port P2 direction	P2DIR	02Ah
	Port P2 output	P2OUT	029h
	Port P2 input	P2IN	028h
Port P1	Port P1 selection	P1SEL	026h
	Port P1 interrupt enable	P1IE	025h
	Port P1 interrupt edge select	P1IES	024h
	Port P1 interrupt flag	P1IFG	023h
	Port P1 direction	P1DIR	022h
	Port P1 output	P1OUT	021h
	Port P1 input	P1IN	020h
Special Function	SFR interrupt flag2	IFG2	003h
	SFR interrupt flag1	IFG1	002h
	SFR interrupt enable2	IE2	001h
	SFR interrupt enable1	IE1	000h



absolute maximum ratings†

Voltage applied at V_{CC} to V_{SS}	–0.3 V to 4.1 V
Voltage applied to any pin (see Note)	–0.3 V to $V_{CC}+0.3$ V
Diode current at any device terminal	±2 mA
Storage temperature, T_{stg} (unprogrammed device)	–55°C to 150°C
Storage temperature, T_{stg} (programmed device)	–40°C to 85°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE: All voltages referenced to V_{SS} . The JTAG fuse-blow voltage, V_{FB} , is allowed to exceed the absolute maximum rating. The voltage is applied to the TEST pin when blowing the JTAG fuse.

recommended operating conditions

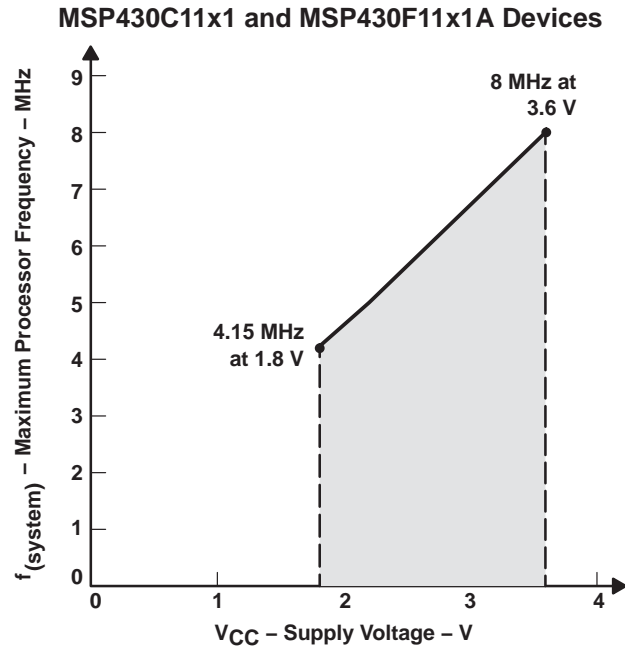
		MIN	NOM	MAX	UNITS	
Supply voltage during program execution, V_{CC} (see Note 1)	MSP430C11x1	1.8		3.6	V	
	MSP430F11x1A	1.8		3.6		
Supply voltage during program/erase flash memory, V_{CC}	MSP430F11x1A	2.7		3.6	V	
Supply voltage, V_{SS}			0		V	
Operating free-air temperature range, T_A	MSP430x11x1(A)	–40		85	°C	
LFXT1 crystal frequency, $f_{(LFXT1)}$ (see Note 2)	LF mode selected, XTS=0	Watch crystal		32768	Hz	
	XT1 mode selected, XTS=1	Ceramic resonator		450	8000	kHz
		Crystal		1000	8000	
Processor frequency $f_{(system)}$ (MCLK signal)	$V_{CC} = 1.8$ V, MSP430x11x1(A)	dc		4.15	MHz	
	$V_{CC} = 3.6$ V, MSP430x11x1(A)	dc		8		
Flash timing generator frequency, $f_{(FTG)}$	MSP430F11x1A	257		476	kHz	
Cumulative program time, block-write, $t_{(CPT)}$ (see Note 3)	$V_{CC} = 2.7$ V/3.6 V MSP430F11x1A			4	ms	
Mass erase time, $t_{(MEras)}$ (See also the <i>flash memory, timing generator, control register FCTL2</i> section, see Note 4)	$V_{CC} = 2.7$ V/3.6 V	200			ms	
Low-level input voltage (TCK, TMS, TDI, \overline{RST}/NMI), V_{IL} (excluding XIN, XOUT)	$V_{CC} = 2.2$ V/3 V	V_{SS}		$V_{SS}+0.6$	V	
High-level input voltage (TCK, TMS, TDI, \overline{RST}/NMI), V_{IH} (excluding XIN, XOUT)	$V_{CC} = 2.2$ V/3 V	$0.8 \times V_{CC}$		V_{CC}	V	
Input levels at XIN, XOUT	$V_{IL}(XIN, XOUT)$	$V_{CC} = 2.2$ V/3 V		V_{SS}	V	
	$V_{IH}(XIN, XOUT)$		$0.8 \times V_{CC}$	$0.2 \times V_{CC}$		

- NOTES: 1. The LFXT1 oscillator in LF mode requires a resistor of 5.1 MΩ from XOUT to V_{SS} when $V_{CC} < 2.5$ V. The LFXT1 oscillator in XT1 mode accepts a ceramic resonator or a crystal frequency of 4 MHz at $V_{CC} \geq 2.2$ V. The LFXT1 oscillator in XT1 mode accepts a ceramic resonator or a crystal frequency of 8 MHz at $V_{CC} \geq 2.8$ V.
2. The LFXT1 oscillator in LF mode requires a watch crystal. The LFXT1 oscillator in XT1 mode accepts a ceramic resonator or a crystal.
3. The cumulative program time must not be exceeded during a block-write operation.
4. The mass erase duration generated by the flash timing generator is at least 11.1 ms. The cumulative mass erase time needed is 200 ms. This can be achieved by repeating the mass erase operation until the cumulative mass erase time is met (a minimum of 19 cycles may be required).

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recommended operating conditions (continued)



NOTE: Minimum processor frequency is defined by system clock. Flash program or erase operations require a minimum V_{CC} of 2.7 V.

Figure 1. Frequency vs Supply Voltage

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

supply current (into V_{CC}) excluding external current

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT	
$I_{(AM)}$	Active mode	C11x1	$T_A = -40^\circ\text{C to } +85^\circ\text{C},$ $f_{(MCLK)} = f_{(SMCLK)} = 1 \text{ MHz},$ $f_{(ACLK)} = 32,768 \text{ Hz}$	$V_{CC} = 2.2 \text{ V}$	160	200	μA	
				$V_{CC} = 3 \text{ V}$	240	300		
			$T_A = -40^\circ\text{C to } +85^\circ\text{C},$ $f_{(MCLK)} = f_{(SMCLK)} = f_{(ACLK)} = 4096 \text{ Hz}$	$V_{CC} = 2.2 \text{ V}$	1.3	2		
				$V_{CC} = 3 \text{ V}$	2.5	3.2		
		F11x1A	$T_A = -40^\circ\text{C to } +85^\circ\text{C},$ $f_{(MCLK)} = f_{(SMCLK)} = 1 \text{ MHz},$ $f_{(ACLK)} = 32,768 \text{ Hz},$ Program executes in flash	$V_{CC} = 2.2 \text{ V}$	200	250		
				$V_{CC} = 3 \text{ V}$	300	350		
		$T_A = -40^\circ\text{C to } +85^\circ\text{C},$ Program executes in flash $f_{(MCLK)} = f_{(SMCLK)} = f_{(ACLK)} = 4096 \text{ Hz}$	$V_{CC} = 2.2 \text{ V}$	3	5			
			$V_{CC} = 3 \text{ V}$	11	18			
$I_{(CPUoff)}$	Low-power mode, (LPM0)	C11x1	$T_A = -40^\circ\text{C to } +85^\circ\text{C},$ $f_{(MCLK)} = 0, f_{(SMCLK)} = 1 \text{ MHz},$ $f_{(ACLK)} = 32,768 \text{ Hz}$	$V_{CC} = 2.2 \text{ V}$	30	40	μA	
				$V_{CC} = 3 \text{ V}$	51	60		
		F11x1A	$T_A = -40^\circ\text{C to } +85^\circ\text{C},$ $f_{(MCLK)} = 0, f_{(SMCLK)} = 1 \text{ MHz},$ $f_{(ACLK)} = 32,768 \text{ Hz}$	$V_{CC} = 2.2 \text{ V}$	32	45		
				$V_{CC} = 3 \text{ V}$	55	70		
$I_{(LPM2)}$	Low-power mode, (LPM2)		$T_A = -40^\circ\text{C to } +85^\circ\text{C},$ $f_{(MCLK)} = f_{(SMCLK)} = 0 \text{ MHz},$ $f_{(ACLK)} = 32,768 \text{ Hz}, \text{ SCG0} = 0$	$V_{CC} = 2.2 \text{ V}$	11	14	μA	
				$V_{CC} = 3 \text{ V}$	17	22		
$I_{(LPM3)}$	Low-power mode, (LPM3)	C11x1	$T_A = -40^\circ\text{C to } +85^\circ\text{C},$ $f_{(MCLK)} = f_{(SMCLK)} = 0 \text{ MHz},$ $f_{(ACLK)} = 32,768 \text{ Hz}, \text{ SCG0} = 1$	$V_{CC} = 2.2 \text{ V}$	1.2	1.7	μA	
				$V_{CC} = 3 \text{ V}$	2	2.7		
		F11x1A	$f_{(MCLK)} = 0 \text{ MHz},$ $f_{(SMCLK)} = 0 \text{ MHz},$ $f_{(ACLK)} = 32,768 \text{ Hz},$ $\text{SCG0} = 1$	$T_A = -40^\circ\text{C}$	$V_{CC} = 2.2 \text{ V}$	0.8		1.2
				$T_A = 25^\circ\text{C}$		0.7		1
				$T_A = 85^\circ\text{C}$	$V_{CC} = 3 \text{ V}$	1.6		2.3
				$T_A = -40^\circ\text{C}$		1.8		2.2
				$T_A = 25^\circ\text{C}$	1.6	1.9		
				$T_A = 85^\circ\text{C}$	2.3	3.4		
$I_{(LPM4)}$	Low-power mode, (LPM4)	C11x1	$f_{(MCLK)} = 0 \text{ MHz},$ $f_{(SMCLK)} = 0 \text{ MHz},$ $f_{(ACLK)} = 0 \text{ Hz}, \text{ SCG0} = 1$	$T_A = -40^\circ\text{C}$	$V_{CC} = 2.2 \text{ V}/3 \text{ V}$	0.1	0.5	μA
				$T_A = 25^\circ\text{C}$		0.1	0.5	
				$T_A = 85^\circ\text{C}$		0.4	0.8	
		F11x1A		$T_A = -40^\circ\text{C}$	$V_{CC} = 2.2 \text{ V}/3 \text{ V}$	0.1	0.5	
				$T_A = 25^\circ\text{C}$		0.1	0.5	
				$T_A = 85^\circ\text{C}$		0.8	1.9	

NOTE: All inputs are tied to 0 V or V_{CC} . Outputs do not source or sink any current.

current consumption of active mode versus system frequency, C version, F version

$$I_{AM} = I_{AM}[1 \text{ MHz}] \times f_{\text{system}} [\text{MHz}]$$

current consumption of active mode versus supply voltage, C version

$$I_{AM} = I_{AM}[3 \text{ V}] + 105 \mu\text{A/V} \times (V_{CC} - 3 \text{ V})$$

current consumption of active mode versus supply voltage, F version

$$I_{AM} = I_{AM}[3 \text{ V}] + 120 \mu\text{A/V} \times (V_{CC} - 3 \text{ V})$$

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electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (continued)

Schmitt-trigger inputs Port P1 and Port P2; P1.0 to P1.7, P2.0 to P2.5

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V _{IT+}	Positive-going input threshold voltage	V _{CC} = 2.2 V	1.1		1.5	V
		V _{CC} = 3 V	1.5		1.9	
V _{IT-}	Negative-going input threshold voltage	V _{CC} = 2.2 V	0.4		0.9	V
		V _{CC} = 3 V	0.9		1.3	
V _{hys}	Input voltage hysteresis (V _{IT+} - V _{IT-})	V _{CC} = 2.2 V	0.3		1.1	V
		V _{CC} = 3 V	0.5		1	

outputs Port 1 to P2; P1.0 to P1.7, P2.0 to P2.5

PARAMETER	TEST CONDITIONS			MIN	TYP	MAX	UNIT
V _{OH} High-level output voltage Port 1 and Port 2 (C11x1) Port 1 (F11x1A)	I _(OHmax) = -1.5 mA	V _{CC} = 2.2 V	See Note 1	V _{CC} -0.25		V _{CC}	V
	I _(OHmax) = -6 mA		See Note 2	V _{CC} -0.6		V _{CC}	
	I _(OHmax) = -1.5 mA	V _{CC} = 3 V	See Note 1	V _{CC} -0.25		V _{CC}	
	I _(OHmax) = -6 mA		See Note 2	V _{CC} -0.6		V _{CC}	
V _{OH} High-level output voltage Port 2 (F11x1A)	I _(OHmax) = -1 mA	V _{CC} = 2.2 V	See Note 3	V _{CC} -0.25		V _{CC}	V
	I _(OHmax) = -3.4 mA		See Note 3	V _{CC} -0.6		V _{CC}	
	I _(OHmax) = -1 mA	V _{CC} = 3 V	See Note 3	V _{CC} -0.25		V _{CC}	
	I _(OHmax) = -3.4 mA		See Note 3	V _{CC} -0.6		V _{CC}	
V _{OL} Low-level output voltage Port 1 and Port 2 (C11x1, F11x1A)	I _(OLmax) = 1.5 mA	V _{CC} = 2.2 V	See Note 1	V _{SS}	V _{SS} +0.25	V	
	I _(OLmax) = 6 mA		See Note 2	V _{SS}	V _{SS} +0.6		
	I _(OLmax) = 1.5 mA	V _{CC} = 3 V	See Note 1	V _{SS}	V _{SS} +0.25		
	I _(OLmax) = 6 mA		See Note 2	V _{SS}	V _{SS} +0.6		

- NOTES: 1. The maximum total current, I_{OHmax} and I_{OLmax}, for all outputs combined, should not exceed ±12 mA to hold the maximum voltage drop specified.
 2. The maximum total current, I_{OHmax} and I_{OLmax}, for all outputs combined, should not exceed ±48 mA to hold the maximum voltage drop specified.
 3. One output loaded at a time.



outputs – Ports P1 and P2 (continued)

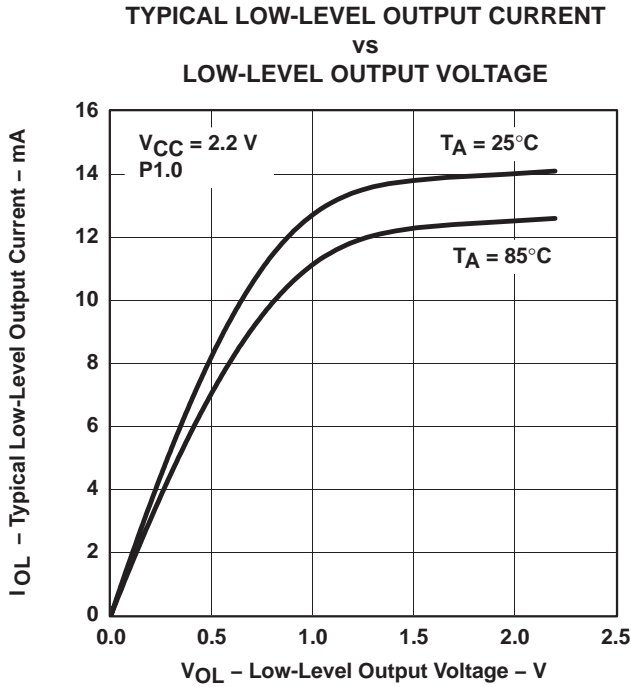


Figure 2

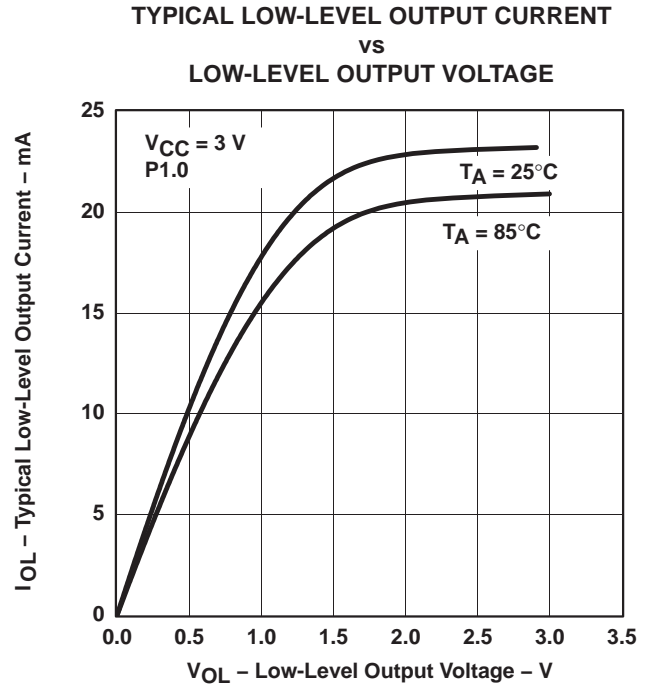


Figure 3

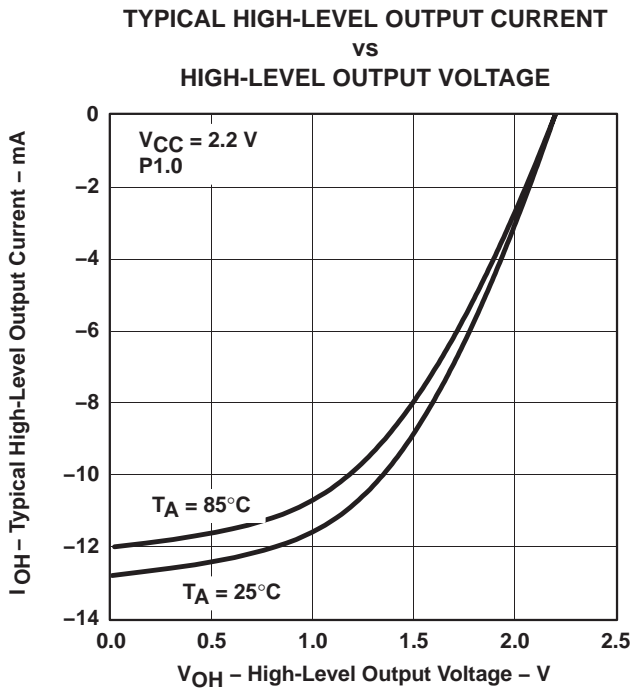


Figure 4

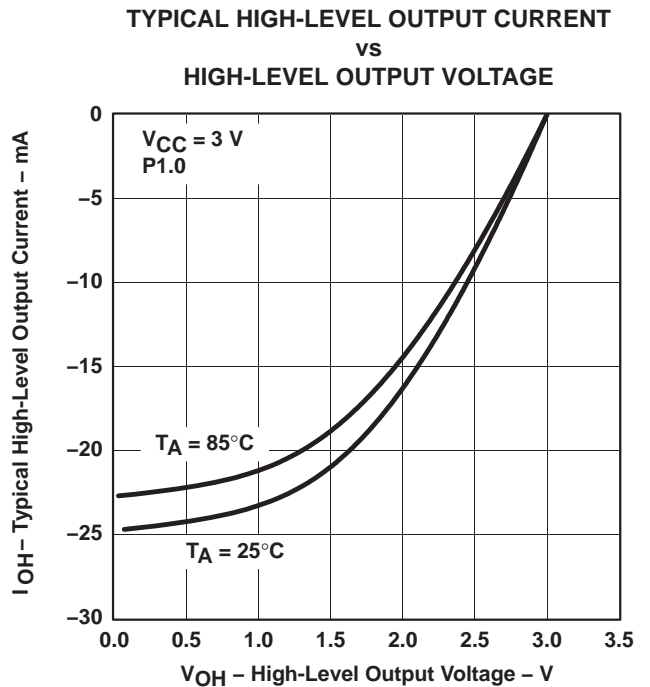


Figure 5

NOTE: One output loaded at a time.

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electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (continued)

leakage current

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I _{lkg} (P _{x.x})	High-impedance leakage current	Port P1: P1.x, 0 ≤ x ≤ 7 (see Notes 1, 2)	V _{CC} = 2.2 V/3 V,		±50	nA
		Port P2: P2.x, 0 ≤ x ≤ 5 (see Notes 1, 2)	V _{CC} = 2.2 V/3 V,		±50	

- NOTES: 1. The leakage current is measured with V_{SS} or V_{CC} applied to the corresponding pin(s), unless otherwise noted.
2. The leakage of the digital port pins is measured individually. The port pin must be selected for input and there must be no optional pullup or pulldown resistor.

optional resistors, individually programmable with ROM code (see Note 1)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
R _(opt1)	Resistors, individually programmable with ROM code, all port pins, values applicable for pulldown and pullup	V _{CC} = 2.2 V/3 V	2.5	5	10	kΩ
R _(opt2)			3.8	7.7	15	kΩ
R _(opt3)			7.6	15	31	kΩ
R _(opt4)			11.5	23	46	kΩ
R _(opt5)			23	45	90	kΩ
R _(opt6)			46	90	180	kΩ
R _(opt7)			70	140	280	kΩ
R _(opt8)			115	230	460	kΩ
R _(opt9)			160	320	640	kΩ
R _(opt10)			205	420	830	kΩ

NOTE 1: Optional resistors R_{optx} for pulldown or pullup are not available in standard flash memory device MSP430F11x1A.

inputs P_{x.x}, T_{Ax}

PARAMETER		TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
t _(int)	External interrupt timing	Port P1, P2: P1.x to P2.x, External trigger signal for the interrupt flag, (see Note 1)	2.2 V/3 V	1.5			cycle
			2.2 V	62			ns
			3 V	50			
t _(cap)	Timer_A, capture timing	TA0, TA1, TA2 (see Note 2)	2.2 V/3 V	1.5			cycle
			2.2 V	62			ns
			3 V	50			
f _(TAext)	Timer_A clock frequency externally applied to pin	TACLK, INCLK t _(H) = t _(L)	2.2 V			8	MHz
			3 V			10	
f _(TAint)	Timer_A clock frequency	SMCLK or ACLK signal selected	2.2 V			8	MHz
			3 V			10	

- NOTES: 1. The external signal sets the interrupt flag every time the minimum t_(int) cycle and time parameters are met. It may be set even with trigger signals shorter than t_(int). Both the cycle and timing specifications must be met to ensure the flag is set. t_(int) is measured in MCLK cycles.
2. The external capture signal triggers the capture event every time the minimum t_(cap) cycle and time parameters are met. A capture may be triggered with capture signals even shorter than t_(cap). Both the cycle and timing specifications must be met to ensure a correct capture of the 16-bit timer value and to ensure the flag is set.



electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (continued)

outputs P1.x, P2.x, TAx

PARAMETER		TEST CONDITIONS		VCC	MIN	TYP	MAX	UNIT
f(P20)	Output frequency	P2.0/ACLK,	C _L = 20 pF	2.2 V/3 V			f _{System}	MHz
f(TAx)		TA0, TA1, TA2,	C _L = 20 pF Internal clock source, SMCLK signal applied (see Note 1)	2.2 V/3 V	dc		f _{System}	
t(Xdc)	Duty cycle of O/P frequency	P1.4/SMCLK, C _L = 20 pF	f _{SMCLK} = f _{LFXT1} = f _{XT1}	2.2 V/3 V	40%		60%	
			f _{SMCLK} = f _{LFXT1} = f _{LF}		35%		65%	
			f _{SMCLK} = f _{LFXT1} /n		50%– 15 ns	50%	50%+ 15 ns	
		P2.0/ACLK, C _L = 20 pF	f _{SMCLK} = f _{DCOCLK}	2.2 V/3 V	50%– 15 ns	50%	50%+ 15 ns	
			f _{P20} = f _{LFXT1} = f _{XT1}	2.2 V/3 V	40%		60%	
			f _{P20} = f _{LFXT1} = f _{LF}		30%		70%	
f _{P20} = f _{LFXT1} /n	50%							
t(TAdc)	TA0, TA1, TA2,	C _L = 20 pF, duty cycle = 50%		2.2 V/3 V	0		±50	ns

NOTE 1: The limits of the system clock MCLK has to be met. MCLK and SMCLK can have different frequencies.

Comparator_A (see Note 1)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
I _(DD)		CAON=1, CARSEL=0, CAREF=0	V _{CC} = 2.2 V	25	40	μA	
			V _{CC} = 3 V	45	60		
I _(Ref ladder/ RefDiode)		CAON=1, CARSEL=0, CAREF=1/2/3, no load at P2.3/CA0/TA1 and P2.4/CA1/TA2	V _{CC} = 2.2 V	30	50	μA	
			V _{CC} = 3 V	45	71		
V _(IC)	Common-mode input voltage	CAON =1	V _{CC} = 2.2 V/3 V	0		V _{CC} -1	V
V _(Ref025)	Voltage @ 0.25 V _{CC} node V _{CC}	PCA0=1, CARSEL=1, CAREF=1, No load at P2.3/CA0/TA1 and P2.4/CA1/TA2	V _{CC} = 2.2 V/3 V	0.23	0.24	0.25	
V _(Ref050)	Voltage @ 0.5 V _{CC} node V _{CC}	PCA0=1, CARSEL=1, CAREF=2, No load at P2.3/CA0/TA1 and P2.4/CA1/TA2	V _{CC} = 2.2 V/3 V	0.47	0.48	0.5	
V _(RefVT)	See Figure 6 and Figure 7	PCA0=1, CARSEL=1, CAREF=3, No load at P2.3/CA0/TA1 and P2.4/CA1/TA2, T _A = 85°C	V _{CC} = 2.2 V	390	480	540	mV
			V _{CC} = 3 V	400	490	550	
V _(offset)	Offset voltage	See Note 2	V _{CC} = 2.2 V/3 V	-30		30	mV
V _{hys}	Input hysteresis	CAON=1	V _{CC} = 2.2 V/3 V	0	0.7	1.4	mV
t _(response LH)		T _A = 25°C, Overdrive 10 mV, without filter: CAF=0	V _{CC} = 2.2 V	160	210	300	ns
			V _{CC} = 3 V	90	150	240	
		T _A = 25°C, Overdrive 10 mV, with filter: CAF=1	V _{CC} = 2.2 V	1.4	1.9	3.4	μs
			V _{CC} = 3 V	0.9	1.5	2.6	
t _(response HL)		T _A = 25°C, Overdrive 10 mV, without filter: CAF=0	V _{CC} = 2.2 V	130	210	300	ns
			V _{CC} = 3 V	80	150	240	
		T _A = 25°C, Overdrive 10 mV, with filter: CAF=1	V _{CC} = 2.2 V	1.4	1.9	3.4	μs
			V _{CC} = 3 V	0.9	1.5	2.6	

NOTES: 1. The leakage current for the Comparator_A terminals is identical to I_{kg}(P_{x.x}) specification.
2. The input offset voltage can be cancelled by using the CAEX bit to invert the Comparator_A inputs on successive measurements. The two successive measurements are then summed together.

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electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (continued)

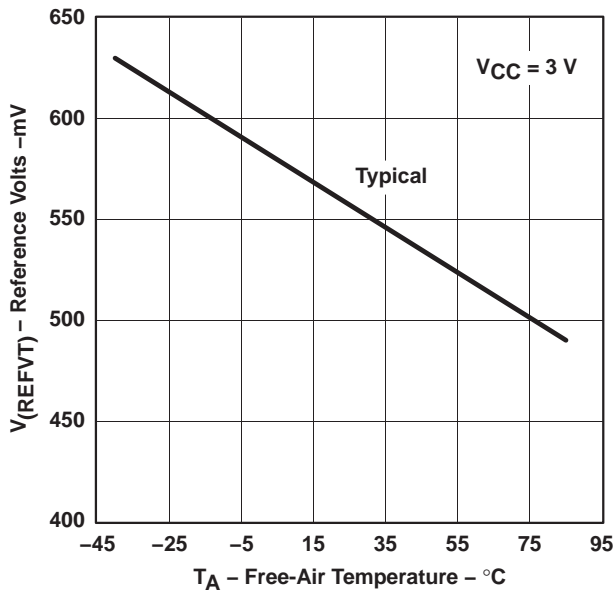


Figure 6. V(REFVT) vs Temperature, V_{CC} = 3 V

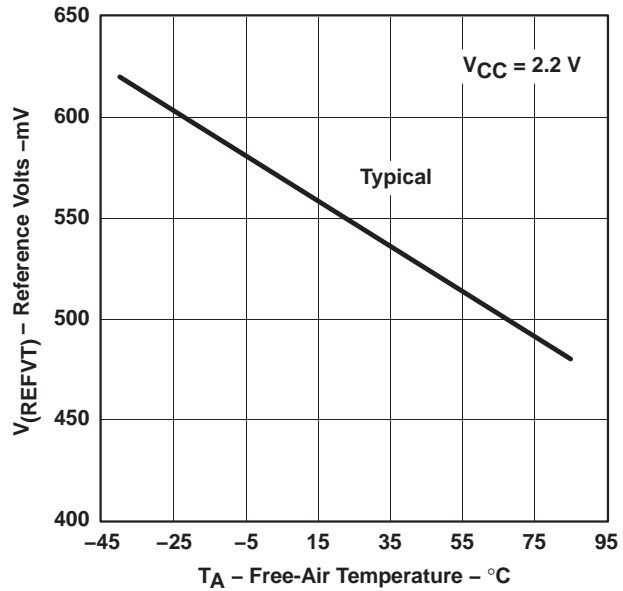


Figure 7. V(REFVT) vs Temperature, V_{CC} = 2.2 V

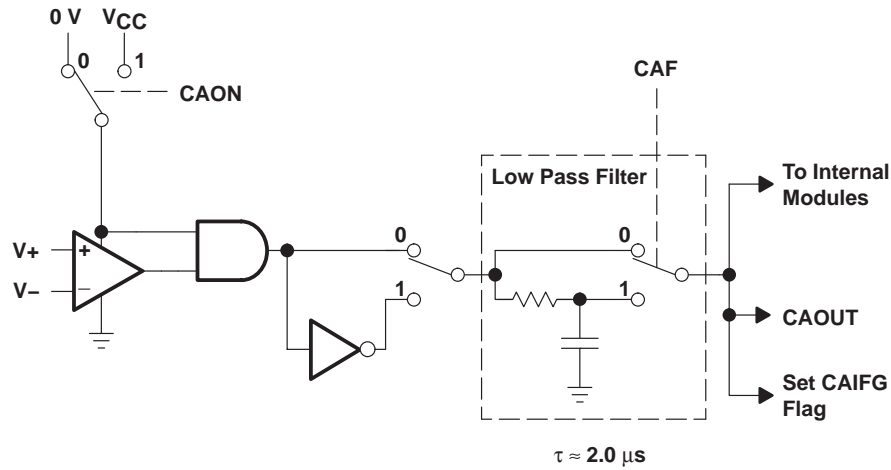


Figure 8. Block Diagram of Comparator_A Module

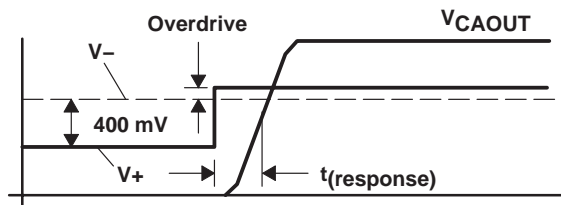


Figure 9. Overdrive Definition

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (continued)

PUC/POR

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
$t_{(POR_Delay)}$					150	250	μs
V_{POR}	POR	$T_A = -40^\circ C$	$V_{CC} = 2.2 V/3 V$	1.4		1.8	V
		$T_A = 25^\circ C$		1.1		1.5	V
		$T_A = 85^\circ C$		0.8		1.2	V
$V_{(min)}$				0		0.4	V
$t_{(reset)}$	PUC/POR	Reset is accepted internally		2			μs

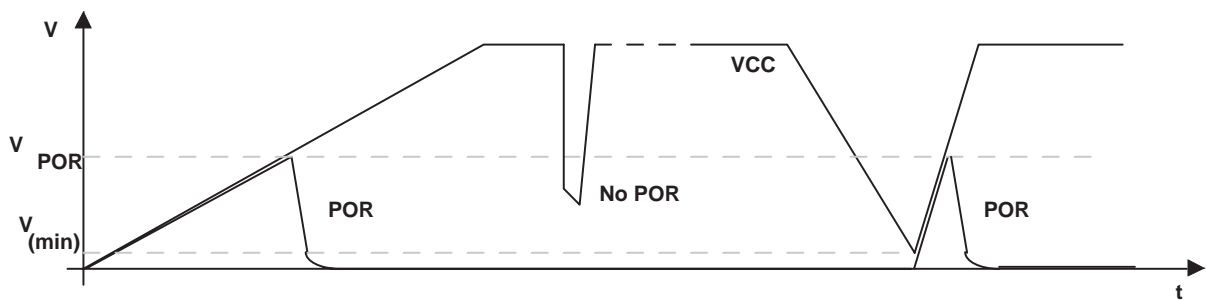


Figure 10. Power-On Reset (POR) vs Supply Voltage

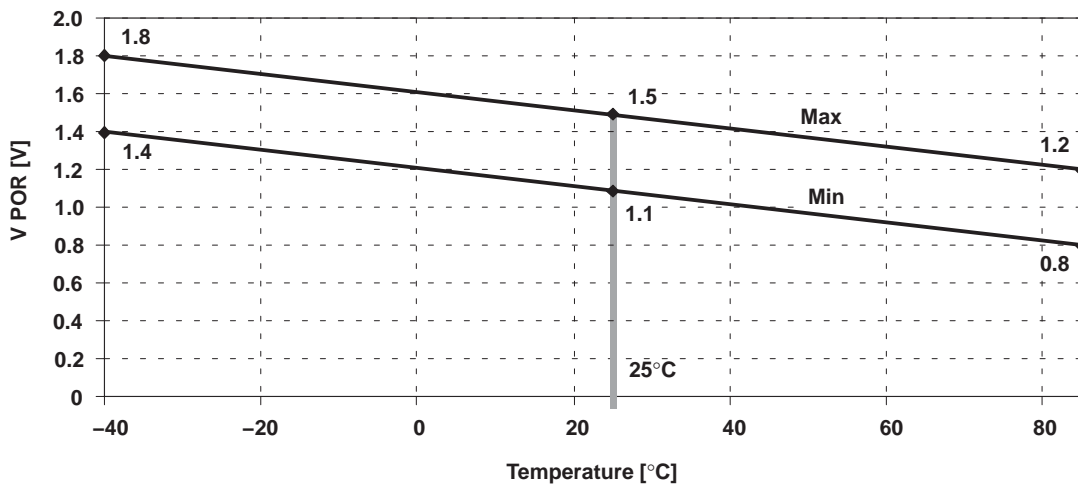


Figure 11. V_{POR} vs Temperature

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electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (continued)

crystal oscillator, LFXT1

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
CXIN	Input capacitance	XTS=0; LF mode selected. V _{CC} = 2.2 V / 3 V		12		pF
		XTS=1; XT1 mode selected. V _{CC} = 2.2 V / 3 V (Note 1)		2		
CXOUT	Output capacitance	XTS=0; LF mode selected. V _{CC} = 2.2 V / 3 V		12		pF
		XTS=1; XT1 mode selected. V _{CC} = 2.2 V / 3 V (Note 1)		2		

NOTE 1: Requires external capacitors at both terminals. Values are specified by crystal manufacturers.

RAM

PARAMETER		MIN	NOM	MAX	UNIT
V(RAMh)	CPU halted (see Note 1)	1.6			V

NOTE 1: This parameter defines the minimum supply voltage V_{CC} when the data in the program memory RAM remains unchanged. No program execution should happen during this supply voltage condition.

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (continued)

DCO

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
f(DCO03)	R _{sel} = 0, DCO = 3, MOD = 0, DCOR = 0, T _A = 25°C	V _{CC} = 2.2 V	0.08	0.12	0.15	MHz
		V _{CC} = 3 V	0.08	0.13	0.16	
f(DCO13)	R _{sel} = 1, DCO = 3, MOD = 0, DCOR = 0, T _A = 25°C	V _{CC} = 2.2 V	0.14	0.19	0.23	MHz
		V _{CC} = 3 V	0.14	0.18	0.22	
f(DCO23)	R _{sel} = 2, DCO = 3, MOD = 0, DCOR = 0, T _A = 25°C	V _{CC} = 2.2 V	0.22	0.30	0.36	MHz
		V _{CC} = 3 V	0.22	0.28	0.34	
f(DCO33)	R _{sel} = 3, DCO = 3, MOD = 0, DCOR = 0, T _A = 25°C	V _{CC} = 2.2 V	0.37	0.49	0.59	MHz
		V _{CC} = 3 V	0.37	0.47	0.56	
f(DCO43)	R _{sel} = 4, DCO = 3, MOD = 0, DCOR = 0, T _A = 25°C	V _{CC} = 2.2 V	0.61	0.77	0.93	MHz
		V _{CC} = 3 V	0.61	0.75	0.9	
f(DCO53)	R _{sel} = 5, DCO = 3, MOD = 0, DCOR = 0, T _A = 25°C	V _{CC} = 2.2 V	1	1.2	1.5	MHz
		V _{CC} = 3 V	1	1.3	1.5	
f(DCO63)	R _{sel} = 6, DCO = 3, MOD = 0, DCOR = 0, T _A = 25°C	V _{CC} = 2.2 V	1.6	1.9	2.2	MHz
		V _{CC} = 3 V	1.69	2	2.29	
f(DCO73)	R _{sel} = 7, DCO = 3, MOD = 0, DCOR = 0, T _A = 25°C	V _{CC} = 2.2 V	2.4	2.9	3.4	MHz
		V _{CC} = 3 V	2.7	3.2	3.65	
f(DCO77)	R _{sel} = 7, DCO = 7, MOD = 0, DCOR = 0, T _A = 25°C	V _{CC} = 2.2 V	4	4.5	4.9	MHz
		V _{CC} = 3 V	4.4	4.9	5.4	
f(DCO47)	R _{sel} = 4, DCO = 7, MOD = 0, DCOR = 0, T _A = 25°C	V _{CC} = 2.2 V/3 V	F _{DCO40} x1.7	F _{DCO40} x2.1	F _{DCO40} x2.5	MHz
S(Rsel)	SR = f _{Rsel+1} /f _{Rsel}	V _{CC} = 2.2 V/3 V	1.35	1.65	2	ratio
S(DCO)	S _{DCO} = f _{DCO+1} /f _{DCO}	V _{CC} = 2.2 V/3 V	1.07	1.12	1.16	
D _t	Temperature drift, R _{sel} = 4, DCO = 3, MOD = 0 (see Note 1)	V _{CC} = 2.2 V	-0.31	-0.36	-0.40	%/ ^o C
		V _{CC} = 3 V	-0.33	-0.38	-0.43	
D _V	Drift with V _{CC} variation, R _{sel} = 4, DCO = 3, MOD = 0 (see Note 1)	V _{CC} = 2.2 V/3 V	0	5	10	%/V

NOTE 1: These parameters are not production tested.

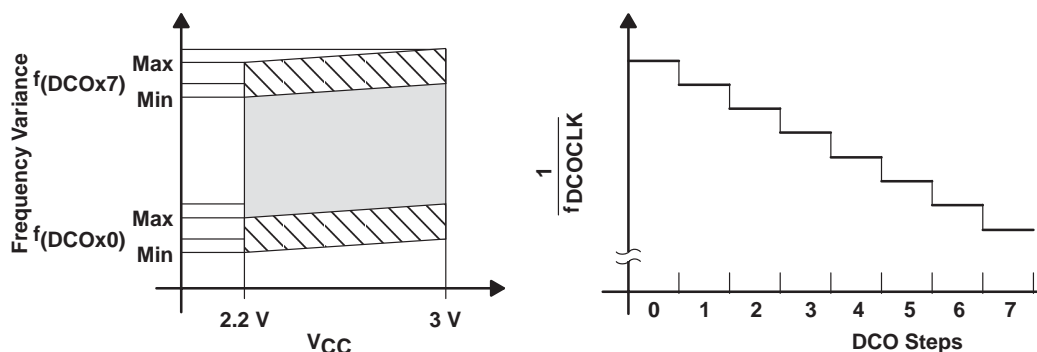


Figure 12. DCO Characteristics

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electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (continued)

principle characteristics of the DCO

- Individual devices have a minimum and maximum operation frequency. The specified parameters for f_{DCOx0} to f_{DCOx7} are valid for all devices.
- DCO control bits DCO0, DCO1, and DCO2 have a step size as defined in parameter S_{DCO} .
- Modulation control bits MOD0 to MOD4 select how often f_{DCO+1} is used within the period of 32 DCOCLK cycles. f_{DCO} is used for the remaining cycles. The frequency is an average = $f_{DCO} \times (2^{MOD/32})$.
- All ranges selected by $Rsel(n)$ overlap with $Rsel(N+1)$: $Rsel0$ overlaps with $Rsel1$, . . . $Rsel6$ overlaps with $Rsel7$.

wake-up from lower power modes (LPMx)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t(LPM0)$	Delay time (see Note 1)	$V_{CC} = 2.2 V/3 V$		100		ns
$t(LPM2)$		$V_{CC} = 2.2 V/3 V$		100		
$t(LPM3)$		$f(MCLK) = 1 MHz, V_{CC} = 2.2 V/3 V$			6	μs
		$f(MCLK) = 2 MHz, V_{CC} = 2.2 V/3 V$			6	
		$f(MCLK) = 3 MHz, V_{CC} = 2.2 V/3 V$			6	
$t(LPM4)$		$f(MCLK) = 1 MHz, V_{CC} = 2.2 V/3 V$			6	μs
		$f(MCLK) = 2 MHz, V_{CC} = 2.2 V/3 V$			6	
		$f(MCLK) = 3 MHz, V_{CC} = 2.2 V/3 V$			6	

NOTE 1: Parameter applicable only if DCOCLK is used for MCLK.

JTAG, program memory and fuse

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$f(TCK)$	TCK frequency, JTAG/test (see Note 3)	$V_{CC} = 2.2 V$	dc		5	MHz
		$V_{CC} = 3 V$	dc		10	
$V_{CC}(FB)$	Supply voltage during fuse blow condition	$T_A = 25^\circ C$	2.5			V
$V_{(FB)}$	Fuse blow voltage, C versions (see Notes 1 and 2)		3.5		3.9	V
	Fuse blow voltage, F versions (see Notes 1 and 2)		6.0		7.0	V
$I_{(FB)}$	Supply current on TEST during fuse blow (see Note 2)				100	mA
$t_{(FB)}$	Time to blow the fuse (see Note 2)				1	ms
$I_{(DD-PGM)}$	Current during program cycle (see Note 4)	$V_{CC} = 2.7 V/3.6 V,$ MSP430F11x1A		3	5	mA
$I_{(DD-ERASE)}$	Current during erase cycle (see Note 4)	$V_{CC} = 2.7 V/3.6 V,$ MSP430F11x1A		3	5	mA
	Erase cycles	MSP430F11x1A	10^4	10^5		
$t_{(retention)}$	Data retention $T_J = 25^\circ C$	MSP430F11x1A	100			Year

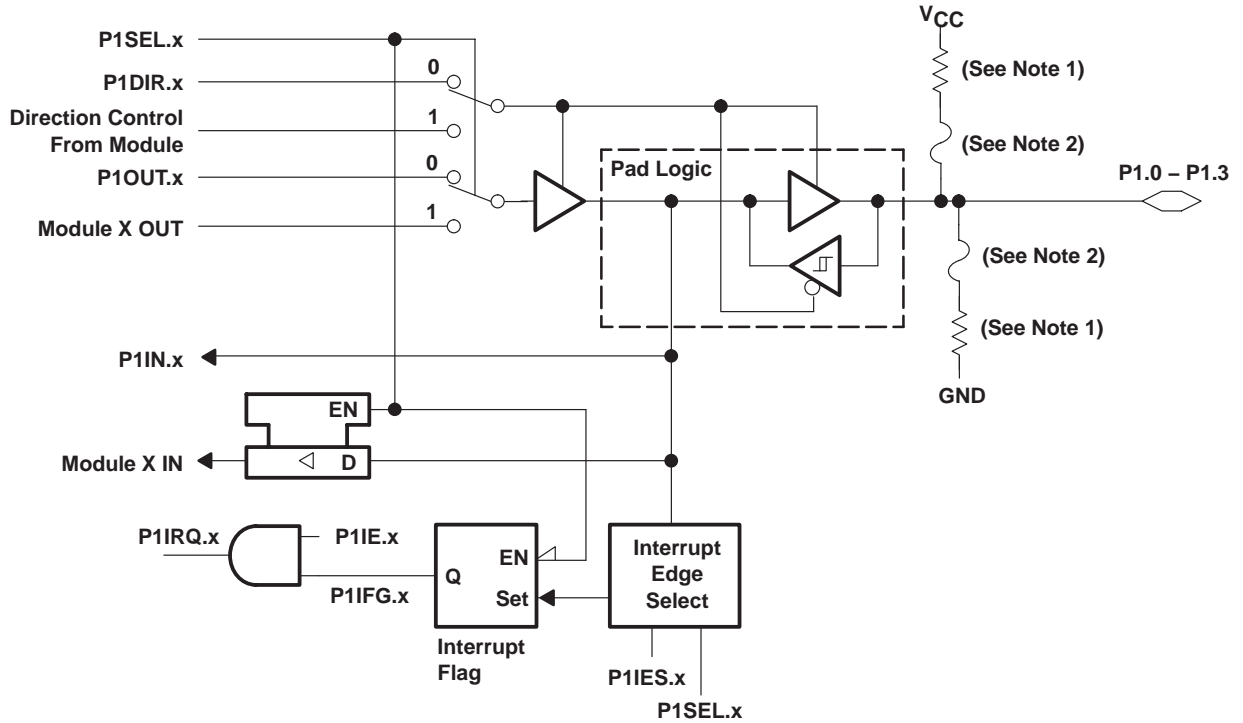
- NOTES: 1. The power source to blow the fuse is applied to the TEST pin.
 2. Once the JTAG fuse is blown, no further access to the MSP430 JTAG/test feature is possible. The JTAG block is switched to bypass mode.
 3. $f(TCK)$ may be restricted to meet the timing requirements of the module selected.
 4. Duration of the program/erase cycle is determined by $f(FTG)$ applied to the flash timing controller. It can be calculated as follows:
 $t(\text{word write}) = 35 \times 1/f(FTG)$
 $t(\text{block write, byte 0}) = 30 \times 1/f(FTG)$
 $t(\text{block write, byte 1 – 63}) = 22 \times 1/f(FTG)$
 $t(\text{block write end sequence}) = 6 \times 1/f(FTG)$
 $t(\text{mass erase}) = 5297 \times 1/f(FTG)$
 $t(\text{segment erase}) = 4819 \times 1/f(FTG)$



APPLICATION INFORMATION

input/output schematic

Port P1, P1.0 to P1.3, input/output with Schmitt-trigger



NOTE: x = Bit/identifier, 0 to 3 for port P1

PnSel.x	PnDIR.x	Direction control from module	PnOUT.x	Module X OUT	PnIN.x	Module X IN	PnIE.x	PnIFG.x	PnIES.x
P1Sel.0	P1DIR.0	P1DIR.0	P1OUT.0	V _{SS}	P1IN.0	TACLK [†]	P1IE.0	P1IFG.0	P1IES.0
P1Sel.1	P1DIR.1	P1DIR.1	P1OUT.1	Out0 signal [†]	P1IN.1	CCI0A [†]	P1IE.1	P1IFG.1	P1IES.1
P1Sel.2	P1DIR.2	P1DIR.2	P1OUT.2	Out1 signal [†]	P1IN.2	CCI1A [†]	P1IE.2	P1IFG.2	P1IES.2
P1Sel.3	P1DIR.3	P1DIR.3	P1OUT.3	Out2 signal [†]	P1IN.3	CCI2A [†]	P1IE.3	P1IFG.3	P1IES.3

[†] Signal from or to Timer_A

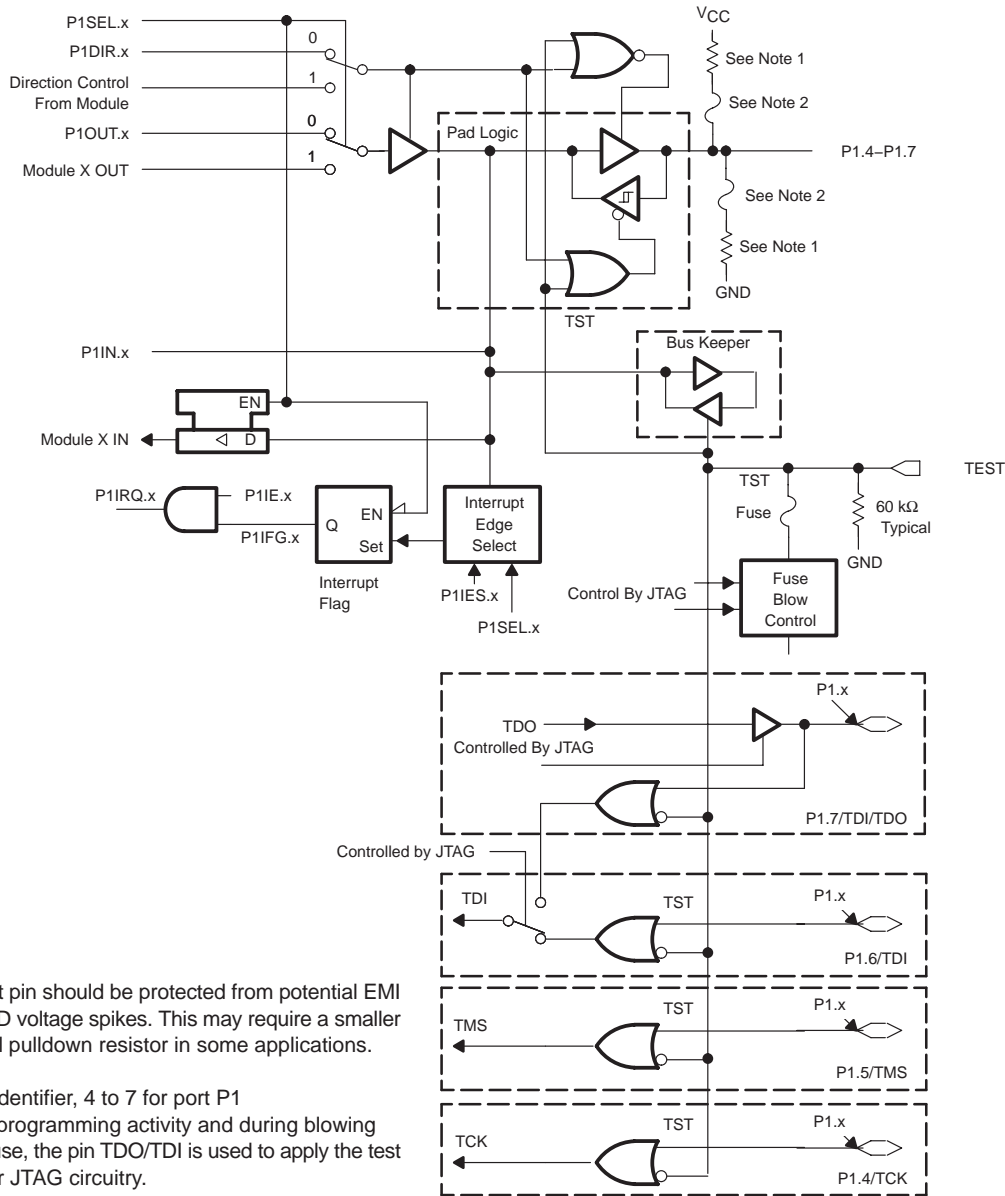
- NOTES: 1. Optional selection of pullup or pulldown resistors with ROM (masked) versions
2. Fuses for optional pullup and pulldown resistors can only be programmed at the factory (ROM versions only).

MSP430C11x1, MSP430F11x1A MIXED SIGNAL MICROCONTROLLER

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APPLICATION INFORMATION

Port P1, P1.4 to P1.7, input/output with Schmitt-trigger and in-system access features



NOTE: The test pin should be protected from potential EMI and ESD voltage spikes. This may require a smaller external pulldown resistor in some applications.

x = Bit identifier, 4 to 7 for port P1
 During programming activity and during blowing of the fuse, the pin TDO/TDI is used to apply the test input for JTAG circuitry.

PnSel.x	PnDIR.x	Direction control from module	PnOUT.x	Module X OUT	PnIN.x	Module X IN	PnIE.x	PnIFG.x	PnIES.x
P1Sel.4	P1DIR.4	P1DIR.4	P1OUT.4	SMCLK	P1IN.4	unused	P1IE.4	P1IFG.4	P1IES.4
P1Sel.5	P1DIR.5	P1DIR.5	P1OUT.5	Out0 signal†	P1IN.5	unused	P1IE.5	P1IFG.5	P1IES.5
P1Sel.6	P1DIR.6	P1DIR.6	P1OUT.6	Out1 signal†	P1IN.6	unused	P1IE.6	P1IFG.6	P1IES.6
P1Sel.7	P1DIR.7	P1DIR.7	P1OUT.7	Out2 signal†	P1IN.7	unused	P1IE.7	P1IFG.7	P1IES.7

† Signal from or to Timer_A

- NOTES: 1. Optional selection of pullup or pulldown resistors with ROM (masked) versions
 2. Fuses for optional pullup and pulldown resistors can only be programmed at the factory (ROM versions only).

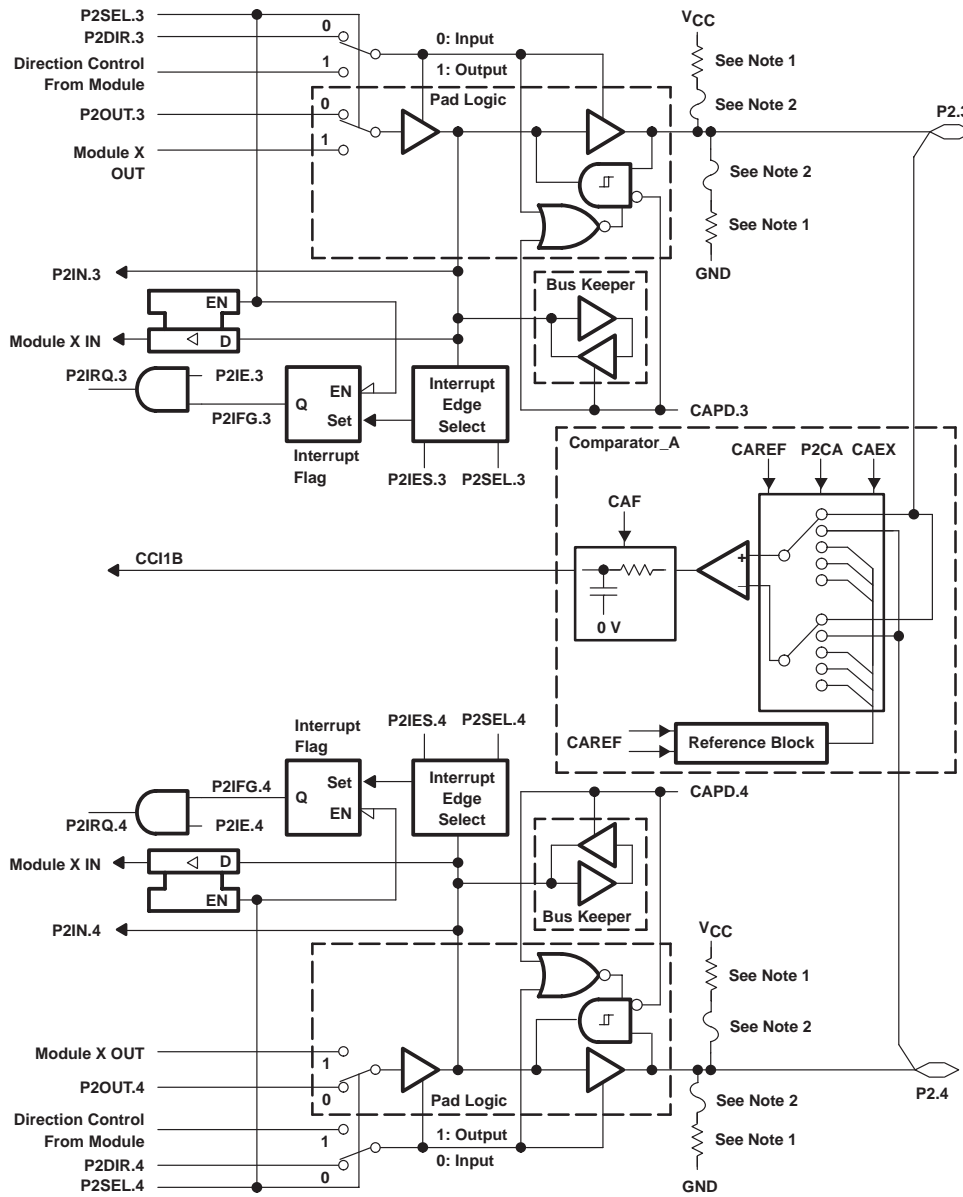


MSP430C11x1, MSP430F11x1A MIXED SIGNAL MICROCONTROLLER

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APPLICATION INFORMATION

Port P2, P2.3 to P2.4, input/output with Schmitt-trigger



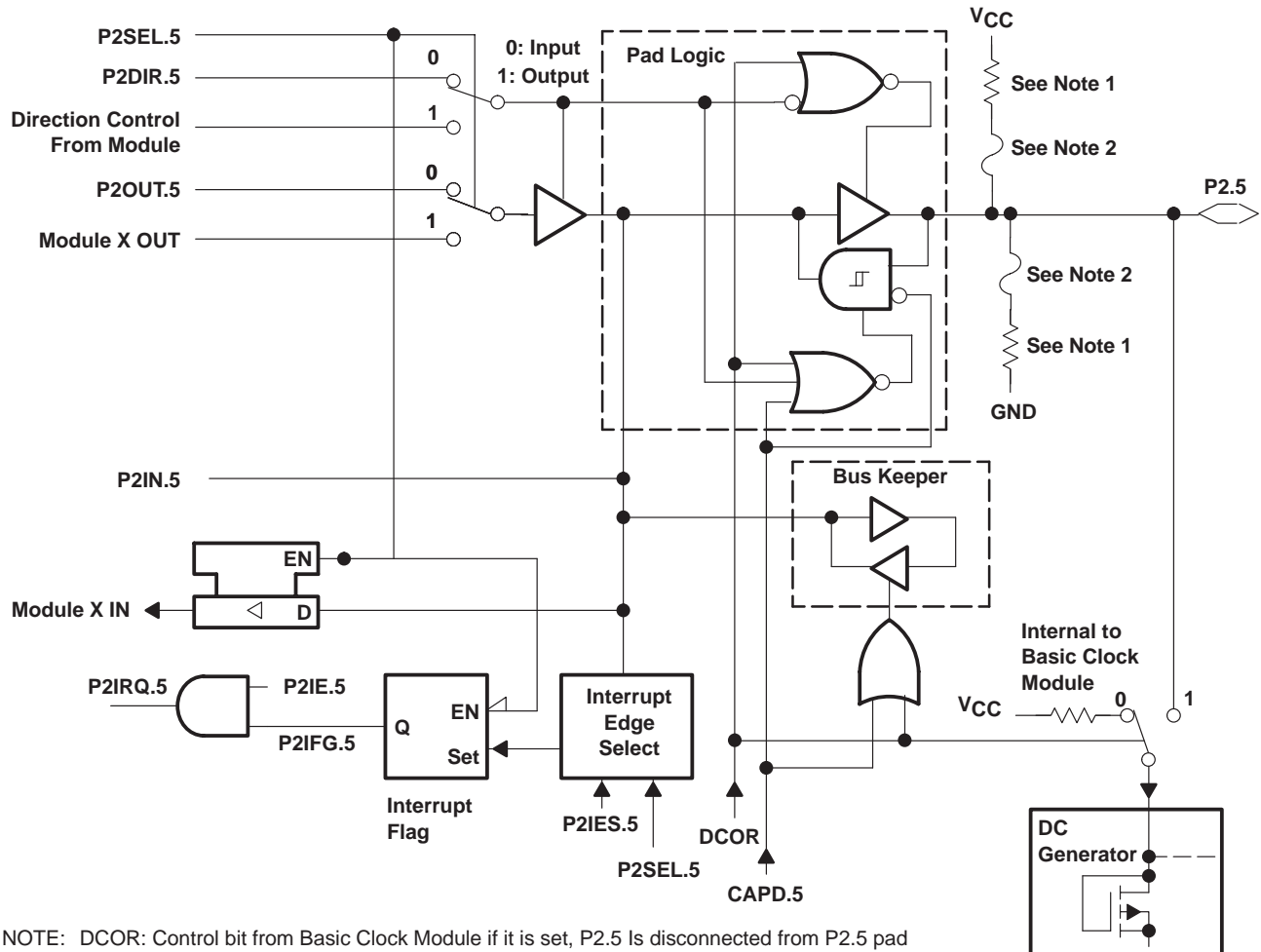
PnSel.x	PnDIR.x	Direction control from module	PnOUT.x	Module X OUT	PnIN.x	Module X IN	PnIE.x	PnIFG.x	PnIES.x
P2Sel.3	P2DIR.3	P2DIR.3	P2OUT.3	Out1 signal [†]	P2IN.3	unused	P2IE.3	P2IFG.3	P1IES.3
P2Sel.4	P2DIR.4	P2DIR.4	P2OUT.4	Out2 signal [†]	P2IN.4	unused	P2IE.4	P2IFG.4	P1IES.4

[†] Signal from Timer_A

NOTES: 1. Optional selection of pullup or pulldown resistors with ROM (masked) versions
2. Fuses for optional pullup and pulldown resistors can only be programmed at the factory (ROM versions only).

APPLICATION INFORMATION

Port P2, P2.5, input/output with Schmitt-trigger and R_{OSC} function for the Basic Clock module



NOTE: DCOR: Control bit from Basic Clock Module if it is set, P2.5 is disconnected from P2.5 pad

PnSel.x	PnDIR.x	Direction control from module	PnOUT.x	Module X OUT	PnIN.x	Module X IN	PnIE.x	PnIFG.x	PnIES.x
P2Sel.5	P2DIR.5	P2DIR.5	P2OUT.5	V _{SS}	P2IN.5	unused	P2IE.5	P2IFG.5	P2IES.5

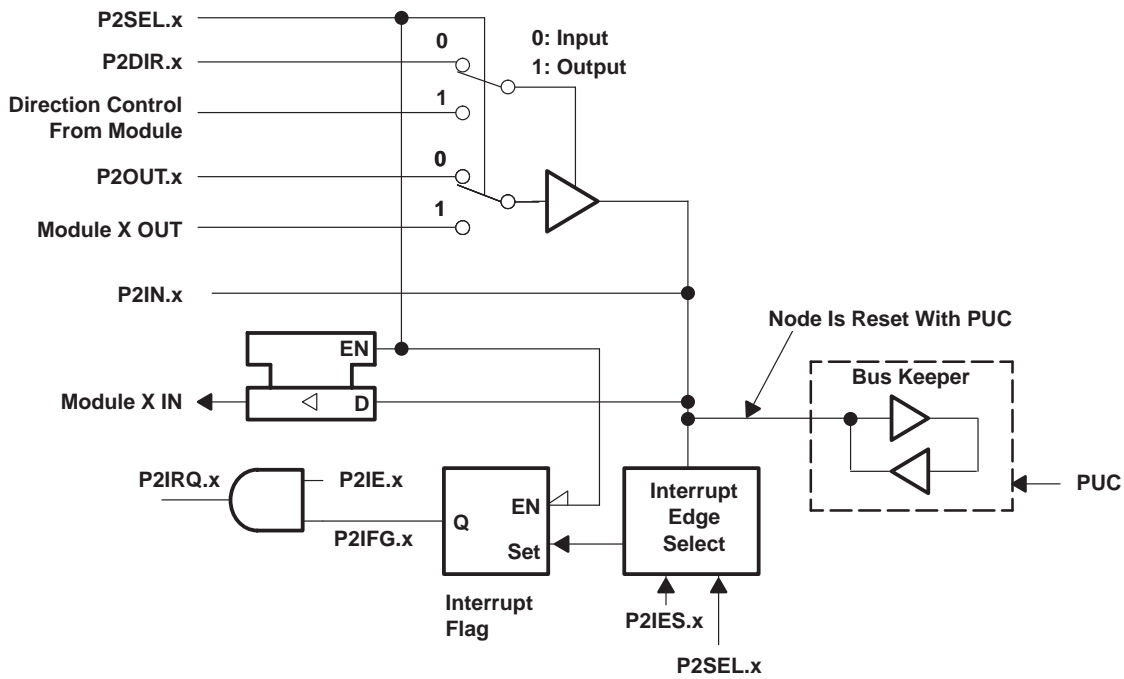
- NOTES: 1. Optional selection of pullup or pulldown resistors with ROM (masked) versions
2. Fuses for optional pullup and pulldown resistors can only be programmed at the factory (ROM versions only).

MSP430C11x1, MSP430F11x1A MIXED SIGNAL MICROCONTROLLER

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APPLICATION INFORMATION

Port P2, unbonded bits P2.6 and P2.7



NOTE: x = Bit/identifier, 6 to 7 for port P2 without external pins

P2Sel.x	P2DIR.x	Direction control from module	P2OUT.x	Module X OUT	P2IN.x	Module X IN	P2IE.x	P2IFG.x	P2IES.x
P2Sel.6	P2DIR.6	P2DIR.6	P2OUT.6	V _{SS}	P2IN.6	unused	P2IE.6	P2IFG.6	P2IES.6
P2Sel.7	P2DIR.7	P2DIR.7	P2OUT.7	V _{SS}	P2IN.7	unused	P2IE.7	P2IFG.7	P2IES.7

NOTE 1: Unbonded bits 6 and 7 of port P2 can be used as software interrupt flags. The interrupt flags can only be influenced by software. They work then as a software interrupt.

JTAG fuse check mode

MSP430 devices that have the fuse on the TEST terminal have a fuse check mode that tests the continuity of the fuse the first time the JTAG port is accessed after a power-on reset (POR). When activated, a fuse check current, I_{TF} , of 1 mA at 3 V, 2.5 mA at 5 V can flow from the TEST pin to ground if the fuse is not burned. Care must be taken to avoid accidentally activating the fuse check mode and increasing overall system power consumption.

When the TEST pin is taken back low after a test or programming session, the fuse check mode and sense currents are terminated.

Activation of the fuse check mode occurs with the first negative edge on the TMS pin after power up or if TMS is being held low during power up. The second positive edge on the TMS pin deactivates the fuse check mode. After deactivation, the fuse check mode remains inactive until another POR occurs. After each POR the fuse check mode has the potential to be activated.

The fuse check current will only flow when the fuse check mode is active and the TMS pin is in a low state (see Figure 13). Therefore, the additional current flow can be prevented by holding the TMS pin high (default condition).

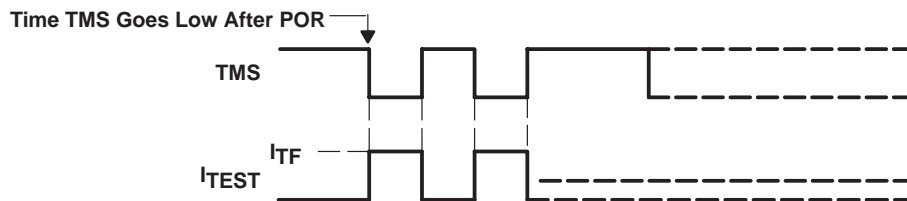


Figure 13. Fuse Check Mode Current, MSP430F11x1A

The JTAG pins are terminated internally, and therefore do not require external termination.

NOTE:

The CODE and RAM data protection is ensured if the JTAG fuse is blown and the 256-bit bootloader access key is used. Also, see the *bootstrap loader* section for more information.

MSP430C11x1, MSP430F11x1A MIXED SIGNAL MICROCONTROLLER

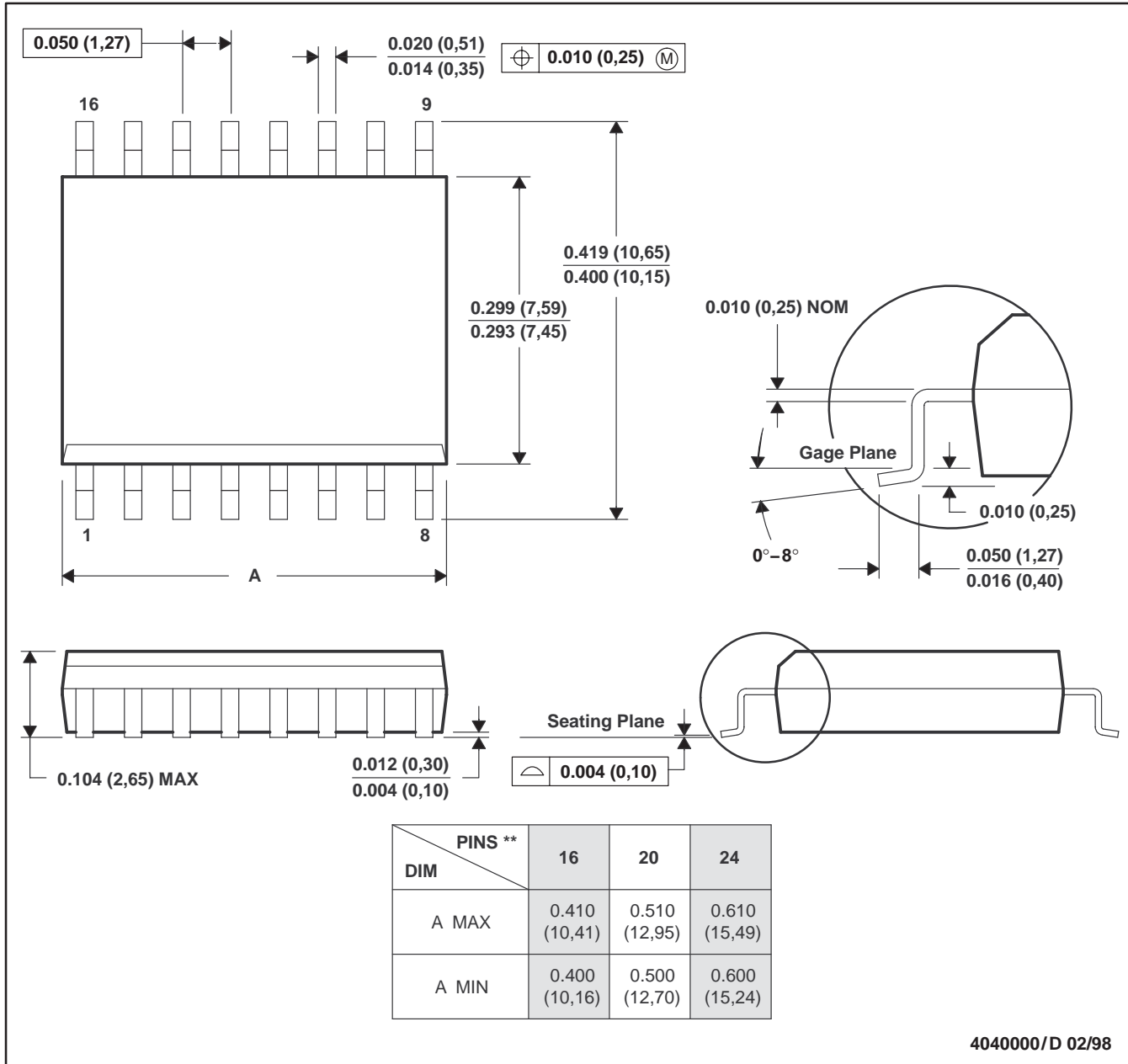
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MECHANICAL DATA

DW (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

16 PIN SHOWN



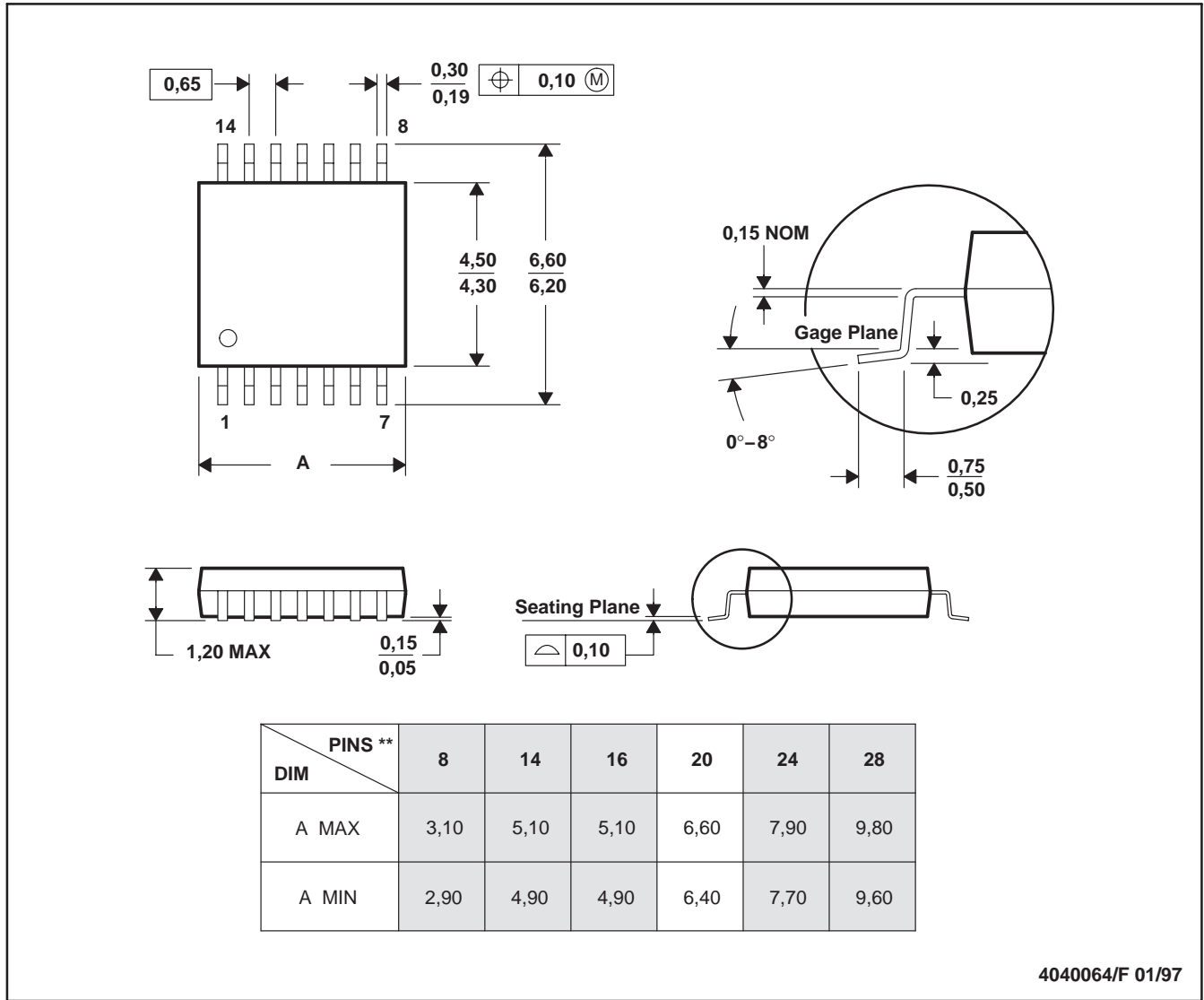
- NOTES: A. All linear dimensions are in inches (millimeters).
 B. This drawing is subject to change without notice.
 C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
 D. Falls within JEDEC MS-013

MECHANICAL DATA

PW (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

14 PINS SHOWN



- NOTES: A. All linear dimensions are in millimeters.
 B. This drawing is subject to change without notice.
 C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
 D. Falls within JEDEC MO-153

MSP430C11x1, MSP430F11x1A MIXED SIGNAL MICROCONTROLLER

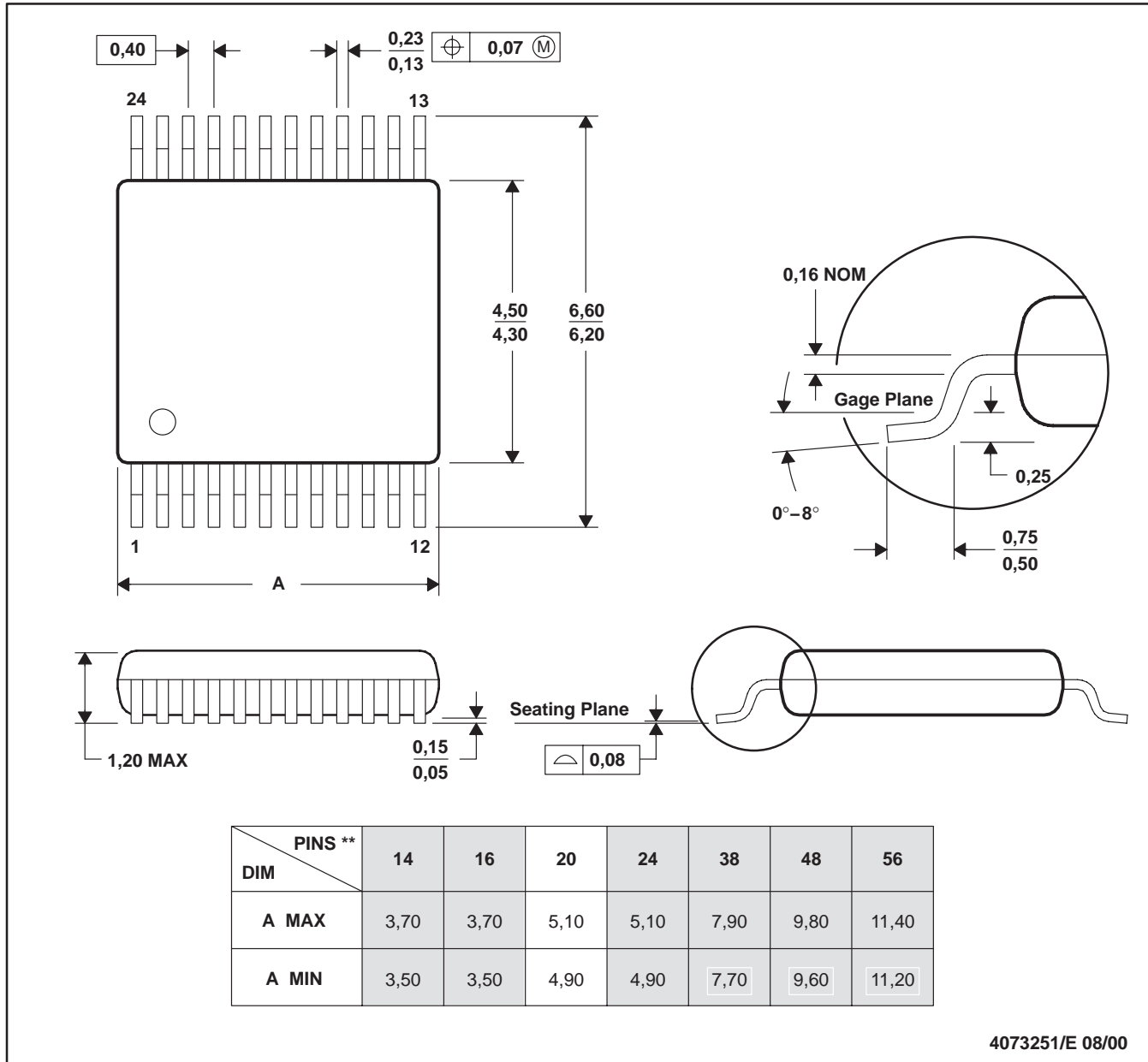
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MECHANICAL DATA

DGV (R-PDSO-G**)

PLASTIC SMALL-OUTLINE

24 PINS SHOWN

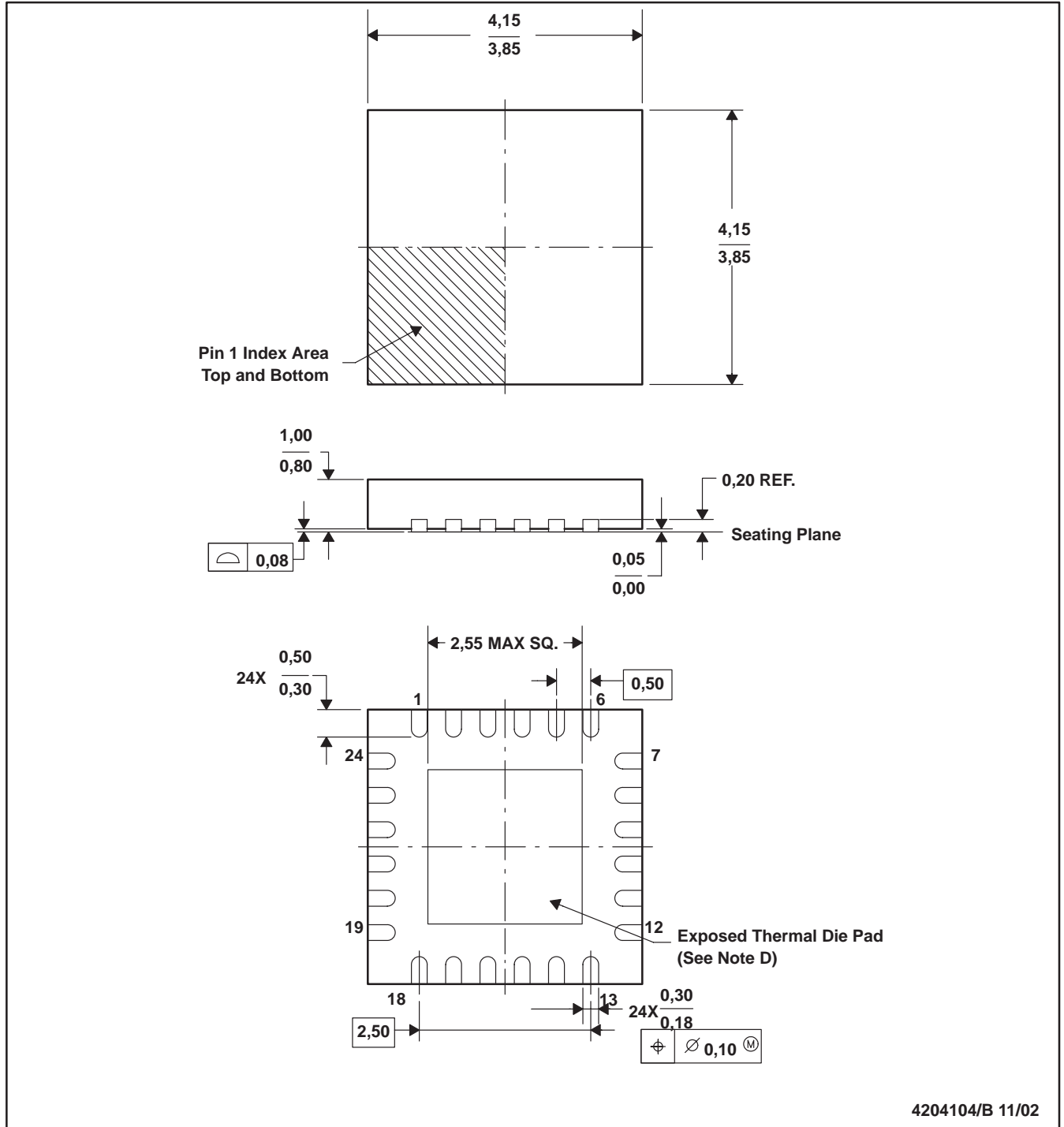


- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
 - D. Falls within JEDEC: 24/48 Pins – MO-153
14/16/20/56 Pins – MO-194

MECHANICAL DATA

RGE (S-PQFP-N24)

PLASTIC QUAD FLATPACK



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Quad Flatpack, No-leads, (QFN) package configuration.
 - D. The package thermal performance may be enhanced by bonding the thermal die pad to an external thermal plane.
 - E. Falls within JEDEC M0-220.

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